

### Test report No: 6168986.50

# **TEST REPORT**

# **Electromagnetic Compatibility (EMC)**

Identification of item tested	EV charging power module
Trademark	<b>WAXWELL</b>
Model and /or type reference	MXR100030
Ratings	AC 285~475V, 50/60Hz
Applicant's name / address	Shijiazhuang Maxwell Technology Co., Ltd.
	Room 601, Building C, Zhongfang Yuantai Plaza, No.66 Tiyu North Street, Chang'an District Shijiazhuang 050000 Hebei P.R. China
Test method requested, standard	IEC 61851-21-2:2018
	EN IEC 61851-21-2:2021
Verdict Summary	IN COMPLIANCE
Tested by (name / position & signature)	Lei Chen Senior Project Manager Adrian Shi Technical Supervisor Adhan Shi
Approved by (name / position & signature)	Adrian Shi
	Technical Supervisor Adulan Shi
Date of issue	2023-08-29
Report template No	TRF_IEC61851-21-2_EMC V1.0

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# **COMPETENCES AND GUARANTEES**

EMTEK (SHENZHEN) CO., LTD. is a testing laboratory competent to carry out the tests described in this report.

In order to assure the traceability to other national and international laboratories, EMTEK (SHENZHEN) CO., LTD. has a calibration and maintenance program for its measurement equipment.

DEKRA guarantees the reliability of the data presented in this report, which is the result of the measurements and the tests performed to the item under test on the date and under the conditions stated in the report and it is based on the knowledge and technical facilities available at DEKRA at the time of performance of the test.

DEKRA is liable to the client for the maintenance of the confidentiality of all information related to the item under test and the results of the test.

The results presented in this Test Report apply only to the particular item under test established in this document.

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# **GENERAL CONDITIONS**

- 1. This report is only referred to the item that has undergone the test.
- 2. This report does not constitute or imply on its own an approval of the product by the Certification Bodies or Competent Authorities.
- 3. This document is only valid if complete; no partial reproduction can be made without previous written permission of DEKRA.
- 4. This test report cannot be used partially or in full for publicity and/or promotional purposes without previous written permission of DEKRA.

# UNCERTAINTY

For all measurements where guidance for the calculation of the instrumentation uncertainty of a measurement is specified in CISPR 16-4-2 (CISPR 16-4-2), EN/IEC 61000-4 series or a product standard, the measurement instrumentation uncertainty has been calculated and applied in accordance with these standards.

Uncertainties have been calculated according to the EMTEK (SHENZHEN) CO., LTD. internal document. The reported expanded uncertainties are based on a standard uncertainty multiplied by a coverage factor of k=2, providing a level of confidence of approximately 95%. Refer to the Annex 1 for furter information.

# **ENVIRONMENTAL CONDITIONS**

The climatic conditions during the tests are within the limits specified by the manufacturer for the operation of the EUT and the test equipment. The climatic conditions during the tests were within the following limits:

Ambient temperature	15 °C – 35 °C
Relative Humidity air	30% - 60%
Atmospheric pressure	86 kPa – 106 kPa

If explicitly required in the basic standard or applied product / product family standard the climatic values are recorded and documented separately in this test report.



# POSSIBLE TEST CASE VERDICTS

Test case does not apply to test object	N/A
Test object does meet requirement	P (Pass) / PASS
Test object does not meet requirement	F (Fail) / FAIL
Not measured	N/M

# **DEFINITION OF SYMBOLS USED IN THIS TEST REPORT**

$\boxtimes$ Indicates that the listed condition, standard or equipment is applicable for this report/test/EUT.				
Indicates that the listed condition, standard or equipment is not applicable for this report/test/EUT.				
Decimal separator used in this report	$\boxtimes$	Comma (,)		Point (.)

# **ABBREVIATIONS**

For the purposes of the present document, the following abbreviations apply:

Equipment Under Test EUT : QP : Quasi-Peak : CISPR Average CAV AV : Average CDN : Coupling Decoupling Network SAC : Semi-Anechoic Chamber OATS : Open Area Test Site BW : Bandwidth AM : Amplitude Modulation : **Pulse Modulation** PΜ HCP : Horizontal Coupling Plane VCP : Vertical Coupling Plane  $U_{\rm N}$ : Nominal voltage Τх : Transmitter Rx : Receiver N/A : Not Applicable N/M : Not Measured TEM Transverse Electromagnetic Mode :



# **DOCUMENT HISTORY**

Report nr.	Date	Description
3126260.50	2021-02-22	First release.
6168986.50	2023-08-29	Updated the standard 'FprEN 61851-21-2: 2017' to 'EN IEC 61851- 21-2:2021'.

# **REMARKS AND COMMENTS**

The equipment under test (EUT) meet the essential requirements of the stated standard(s)/test(s).

The test results relate only to the samples tested.

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This report is issued base on Dekra report No.: 3126260.50 to updated the standard 'FprEN 61851-21-2: 2017' to 'EN IEC 61851-21-2:2021' and change address for applicant/manufacturer. After technology evaluation, no additional test is required.



# 1 **GENERAL INFORMATION**

# 1.1 General Description of the Item(s)

Description of the item:	EV charging power module
Model / Type number:	MXR100030
Trademark:	<b>MAXWELL</b>
Manufacturer:	Shijiazhuang Maxwell Technology Co., Ltd.
	Room 601, Building C, Zhongfang Yuantai Plaza, No.66 Tiyu North Street, Chang'an District Shijiazhuang 050000 Hebei P.R. China

Rated power supply:	Voltage and Frequency		Reference poles					
			L2	L3	Ν	PE		
	AC: 285 ~ 475V, 50/60Hz	$\square$	$\square$	$\square$		$\boxtimes$		
	Battery:							
Rated Power:	30KW							
Clock frequencies:	≤ 108MHz							
Other parameters:	N/A							
Software version:	Not provided							
Hardware version:	Not provided							
Dimensions in cm (W x H x D):	Not provided							
Mounting position:	Table top equipment							
	Wall/Ceiling mounted equipment							
	Floor standing equipment							
	Hand-held equipment							
	Other:							

No	Module/parts of test item				Type Manufacturer		
N/A	N/A	N/A					
No	Documents as provided by the	he appli		File name	Issue date		
N/A	N/A			N/A	N/A		
Modifications to the test item during testing: N/A					Supplemental Information		
Copy of	Copy of marking plate:						
N/A	N/A						



# 1.2 The environment(s) in which the EUT is intended to be used

The equipment under test (EUT) is intended to be used in the following environment(s):

	Residential (domestic) environment.
	Commercial and light-industrial environment.
$\boxtimes$	Environments other than residential
	Healthcare environments (hospitals, clinics, doctor's offices)
	Vehicular environment

### 1.3 Test data

Test Location	EMTEK (SHENZHEN) CO., LTD.
	Bldg 69, Majialong Industry Zone, Nanshan Distri ct, Shenzhen, Guangdong, China
Date of receipt of test item	2020-10-13
Date (s) of performance of tests	2020-10-21 to 2020-11-04

### 1.4 **Classification according to IEC 61851-21-2**

The equipment under test (EUT) is classified as follows, and this classification apply for the emission test :

Class A	Class A off-board electric vehicle charging systems is equipment suitable for use in all locations other than residential ones and those directly connected to a low voltage power supply network which supplies buildings used for residential purposes.
Class B	Class B off-board electric vehicle charging systems is equipment suitable for use in residential establishments and in establishments directly connected to a low voltage power supply network which supplies buildings used for residential purposes. In-cable control and protective devices (IC-CPD) and other mobile charging equipment shall be tested as off-board charging equipment meeting Class B emission requirements (residential).

The equipment under test (EUT) is classified as follows, and this classification apply for the immunity test :

	Category 1	a.c. charging immunity requirements – Environments other than residential
	Category 2	a.c. charging immunity requirements – Residential environments
$\boxtimes$	Category 3	d.c. charging immunity requirements – Environments other than residential
	Category 4	d.c. charging immunity requirements – Residential environments



# 2 **DESCRIPTION OF TEST SETUP**

### 2.1 **Operating mode(s) used for tests**

During the tests the following operating mode(s) has(have) been used.

Operating mode	Operating mode description	Used for testing			
mode		Emission	Immunity		
1	Standby		$\boxtimes$		
2	Load 20%	$\boxtimes$	$\boxtimes$		
3	3 Load 80%				
Supplemental information:					

# 2.2 **Port(s) of the EUT**

	Connected to /	Cable			
Port name and description	Termination	Length used	Attached	Shielded	
	d		during test	Onleided	
AC input port	AC supply	1.4	$\boxtimes$		
CPT port	Resistive Load	1.4	$\boxtimes$		
Supplemental information:					

# 2.3 Support / Auxiliary equipment / unit / software for the EUT

The EUT has been tested with the following auxiliary equipment / unit / software:

Auxiliary equipment / unit / software	Type / Version	Manufacturer	Supplied by
Resistive Load	N/A	BSX	EMTEK
Supplemental information:			



# 3 VERDICT SUMMARY SECTION

This chapter presents an overview of standards and results. Refer to the next chapters for details of measured test results and applied test levels.

### 3.1 Standards

Standard	Year	Description	
IEC 61851-21-2	2018	Electric vehicle conductive charging system - Part 21-2: Electric vehicle requirements for conductive connection to an AC/DC supply – EMC requirements for off board electric vehicle charging systems	
EN IEC 61851-21-2	2021	Electric vehicle conductive charging system - Part 21-2: Electric vehicle requirements for conductive connection to an AC/DC supply - EMC requirements for off board electric vehicle charging systems	
EN61000-6-3	2007	Electromagnetic compatibility (EMC) - Part 6-3: Generic standards -	
+A1	2011	Emission standard for equipment in residential environments	
+AC	2012		
EN 61000-6-1	2007	Electromagnetic compatibility (EMC) - Part 6-1: Generic standards - Immunity for residential, commercial and light-industrial environments	
CISPR 11	2015	Industrial, scientific and medical equipment - Radio-frequency disturbance	
+A1	2016	characteristics - Limits and methods of measurement	
CISPR 16-2-1	2014	Methods of measurement of disturbances and immunity - Conducted	
+A1	2017	disturbance measurements.	
CISPR 16-2-3	2016	Methods of measurement of disturbances and immunity – Radiated disturbance measurements.	
CISPR 32	2015	Electromagnetic compatibility of multimedia equipment – Emission requirements.	
IEC 61000-6-3	2011	Generic standards – Emission standard for residential, commercial and light-industrial environments	
IEC 61000-6-1	2016	Generic standards – Emission standard for residential, commercial and light-industrial environments	
IEC 61000-3-2	2018	Limits for harmonic current emissions (equipment input current ≤ 16 A per phase).	
IEC 61000-3-12	2011	Electromagnetic compatibility (EMC) - Part 3-12: Limits - Limits for harmonic currents produced by equipment connected to public low-voltage systems with input current > 16 A and $\leq$ 75 A per phase.	
IEC 61000-3-3 +A1	2013 2018	Limitation of voltage changes, voltage fluctuations and flicker in public lowvoltage supply systems, for equipment with rated current ≤ 16 A per phase and not subject to conditional connection.	
IEC 61000-3-11		Electromagnetic compatibility (EMC) - Part 3-11: Limits - Limitation of voltage changes, voltage fluctuations and flicker in public low-voltage supply systems - Equipment with rated current $\leq$ 75 A and subject to conditional connection.	
IEC 61000-4-2	2008	Electrostatic discharge immunity test.	
IEC 61000-4-3	2006	Radiated, radio-frequency, electromagnetic field immunity test.	
+A1	2007		
+A2	2010		
IEC 61000-4-4	2012	Electrical fast transient/burst immunity test.	
IEC 61000-4-5	2014	Surge immunity test.	
IEC 61000-4-6	2013	Immunity to conducted disturbances, induced by radio-frequency fields.	
IEC 61000-4-8	2009	Power frequency magnetic field immunity test.	



Standard	Year	Description
IEC 61000-4-11	2004	Voltage dips, short interruptions and voltage variations immunity tests.
A1	2017	
IEC 61000-4-34	2005	Voltage dips, short interruptions and voltage variations immunity tests for
A1	2009	equipment with mains current more than 16A per phase.

# 3.2 **Deviation(s) from the Standard(s) / Test Specification(s)**

The following deviation(s) was / were made from the published requirements of the listed standards: N/A.

### 3.3 **Overview of results**

EMISSION TESTS – EN 61000-6-3					
Requirement – Test case	Basic standard(s)	Verdict	Remark		
Conducted disturbance voltage at mains power input / output port(s)	CISPR 16-2-1	PASS			
Conducted disturbance voltage at wired network port or Signal/control port	CISPR 16-2-1	PASS			
Radiated electromagnetic disturbances (2 - 185KHz & 30 – 1000 MHz)	CISPR 16-2-3	PASS			
Radiated electromagnetic disturbances (above 1 GHz)	CISPR 16-2-3	N/A	See 1)		
Harmonic current emissions	IEC 61000-3-2 IEC 61000-3-12	PASS			
Voltage changes, voltage fluctuations and flicker       IEC 61000-3-3 IEC 61000-3-11       PASS					
Supplementary information:		· · · ·			
1) Highest internal frequency of the EUT $\leq$ 108MHz.					

andard(s)         Verdict           00-4-2         PASS           00-4-3         PASS           00-4-4         PASS	
00-4-3 PASS 00-4-4 PASS	
00-4-4 PASS	
00-4-5 PASS	
00-4-6 PASS	
00-4-8 PASS	
00-4-11 PASS 00-4-34	
)	00-4-8 PASS 00-4-11 PASS



### 3.4 Test Matrix

		Model / Type			
EMISSION TESTS	Mode 1	Mode 2	Mode 3		
Conducted disturbance voltage at mains power input / output port(s) (150 KHz – 30 MHz)					
Conducted disturbance voltage at wired network port or		$\square$			
Signal/control port (150 KHz – 30 MHz)					
Radiated electromagnetic disturbances		$\square$	$\boxtimes$		
(2 - 185KHz & 30 – 1000 MHz)					
Radiated electromagnetic disturbances (above 1GHz)		$\square$	$\square$		
Harmonic current emissions					
Voltage changes, voltage fluctuations and flicker					
Supplamentary: Information:					
<u></u>					

	Model / Type			
IMMUNITY TESTS	Mode 1	Mode 2	Mode 3	
Electrostatic discharge	$\boxtimes$	$\square$		
Radio-frequency electromagnetic fields	$\boxtimes$			
Fast transients	$\square$	$\square$		
Surges	$\square$			
Injected currents (radio-frequency common mode)	$\square$	$\square$		
Power frequency magnetic field immunity	$\square$	$\square$		
Voltage dips and short interruptions	$\boxtimes$			
Supplamentary: Information:				



# 4 EMISSION TEST RESULTS

# 4.1 Conducted disturbance voltage – Mains power port(s) VERDICT: PASS

Standard	IEC 61851-21-2
Basic standard(s)	CISPR 16-2-1

### Limits - Class A (a.c. mains power port)

Frequency	•	ut power of ) kVA	•	ut power of o≦ 75 kVA	Rated inp of >7	out power 5 kVA		Detector(a)
range [MHz]	Limit: QP [dB(µV) <sup>1)</sup> ]	Limit: AV [dB(µV) <sup>1)</sup> ]	Limit: QP [dB(µV) <sup>1)</sup> ]	Limit: AV [dB(µV) <sup>1)</sup> ]	Limit: QP [dB(µV) <sup>1)</sup> ]	Limit: AV [dB(µV) <sup>1)</sup> ]	IF BW	Detector(s)
0,15 - 0,50	79	66	100	90	130	120	9 KHz	QP, CAV
0,50 - 5,0	73	60	86	76	125	115	9 KHz	QP, CAV
5,0 - 30	73	60	90-73	80-60	115	105	9 KHz	QP, CAV
<sup>1)</sup> At the transit	<sup>1)</sup> At the transition frequency, the lower limit applies.							

### Limits - Class B (a.c. mains power port)

Frequency range [MHz]	Limit: QP [dB( $\mu$ V) <sup>1)</sup> ]	Limit: AV [dB( $\mu$ V) <sup>1)</sup> ]	IF BW	Detector(s)				
0,15 - 0,50	66 – 56 <sup>2)</sup>	56 - 46 <sup>2)</sup>	9 KHz	QP, CAV				
0,50 - 5,0	56	46	9 KHz	QP, CAV				
5,0 - 30	60	50	9 KHz	QP, CAV				
	1) At the transition frequency, the lower limit applies.       2) The limit decreases linearly with the logarithm of the frequency.							

### Limits - d.c. mains power port

Frequency	Rated input power of ≦ 75 kVA		Rated input po	wer of >75 kVA	IF BW	
range [MHz]	Limit: QP [dB(µV) <sup>1)</sup> ]	Limit: AV [dB(µV) <sup>1)</sup> ]	Limit: QP [dB(µV) <sup>1)</sup> ]	Limit: AV [dB(µV) <sup>1)</sup> ]		Detector(s)
0,15 - 0,50	79	66	100	90	9 KHz	QP, CAV
0,50 - 5,0	73	60	86	76	9 KHz	QP, CAV
5,0 - 30	73	60	90-73	80-60	9 KHz	QP, CAV
<sup>1)</sup> At the transition frequency, the lower limit applies.						

### Limits - Class A equipment for AC CPT port

Frequency range [MHz]	Limit: QP [dB( $\mu$ V) <sup>1)</sup> ]	Limit: AV [dB( $\mu$ V) <sup>1)</sup> ]	IF BW	Detector(s)
0,15 - 0,50	79	66	9 KHz	QP, CAV
0,50 - 30	73	60	9 KHz	QP, CAV

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### Limits - Class B equipment for AC CPT port

Frequency range [MHz]	Limit: QP [dB(µV) <sup>1)</sup> ]	Limit: AV [dB( $\mu$ V) <sup>1)</sup> ]	IF BW	Detector(s)				
0,15 - 0,50	66 – 56	56 - 46	9 KHz	QP, CAV				
0,50 - 5,0	56	46	9 KHz	QP, CAV				
5,0 - 30	60	50	9 KHz	QP, CAV				
<sup>1)</sup> At the transition frequency, the le	<sup>1)</sup> At the transition frequency, the lower limit applies.							

### Limits - DC CPT port

Frequency	equency ≦ 75		ted input power of $\leq 75 \text{ kVA}$ Rated input power of >75 kV			Detector(s)		
range [MHz]	Limit: QP [dB(µV) <sup>1)</sup> ]	Limit: AV [dB(µV) <sup>1)</sup> ]	Limit: QP [dB(µV) <sup>1)</sup> ]	Limit: AV [dB(μV) <sup>1)</sup> ]	IF BW	Detector(s)		
0,15 - 0,50	79	66	100	90	9 KHz	QP, CAV		
0,50 - 5,0	73	60	86	76	9 KHz	QP, CAV		
5,0 - 30	73	60	90-73	80-60	9 KHz	QP, CAV		
<sup>1)</sup> At the transition	<sup>1)</sup> At the transition frequency, the lower limit applies.							

### Performed measurements

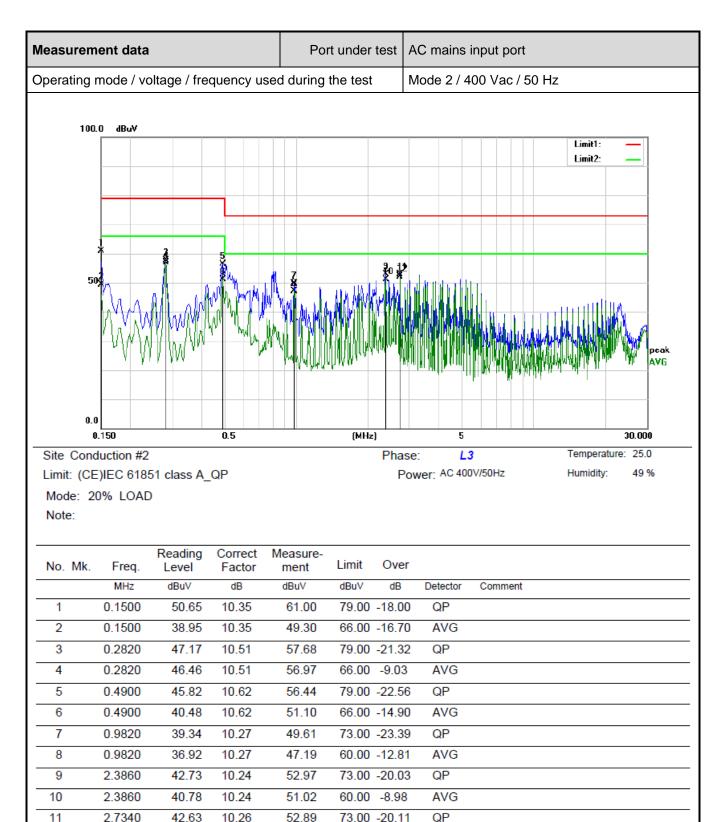
Port under test						Term	ninal				
$\square$	AC mains input port				N	$\square$	L1	$\boxtimes$	L2	$\square$	L3
	AC CPT port				Ν		L1		L2		L3
$\square$	DC CPT port			$\square$	Ν			$\boxtimes$	Р		
Volta	ige – Mains [V]	400V	ac								
Frequency – Mains [Hz] 50Hz											
Test	method applied		Artificial mains net	work							
			Voltage probe								
Test	setup	$\square$	Table top		Artificia	al hanc	applied				
			Floor standing		Other:						
Refer to the Annex 3 for				test se	etup pho	to(s).					
Oper	rating mode(s) used	Mode	e 2, Mode 3								
Rem	ark										

See next page.

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2.7340

12 \*

10.26

41.90

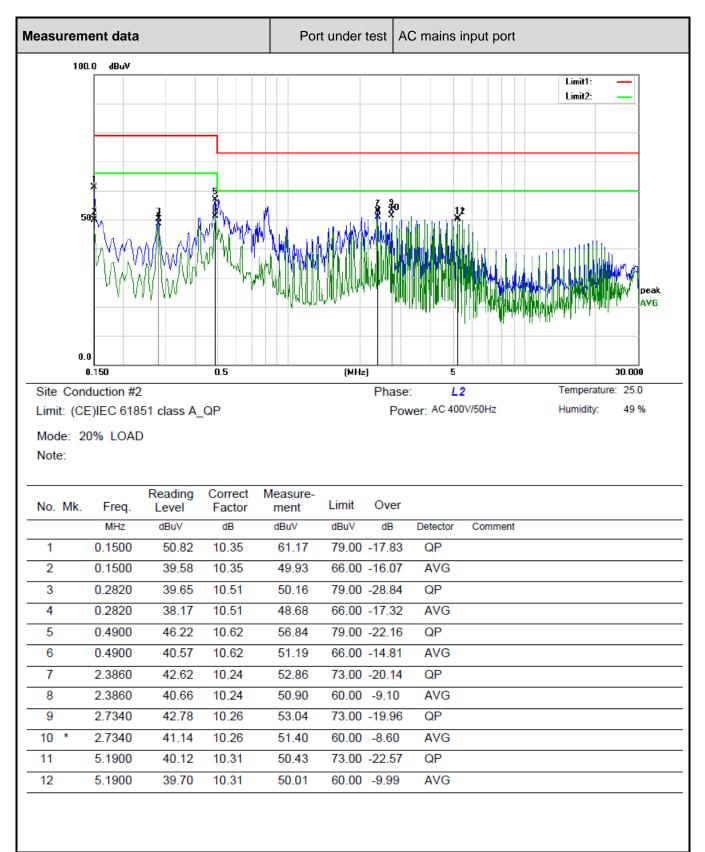
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AVG

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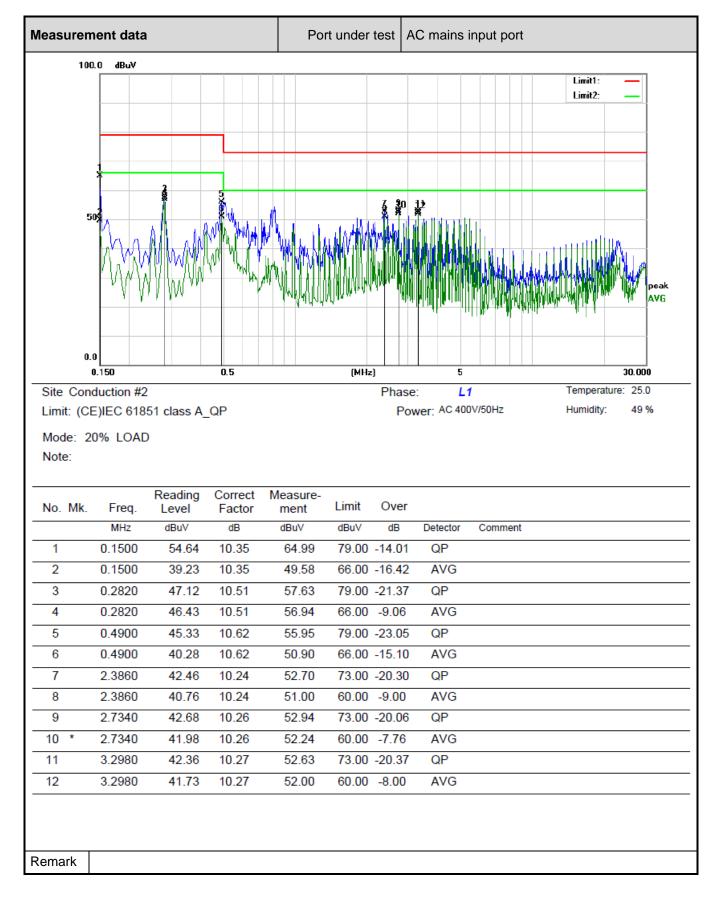
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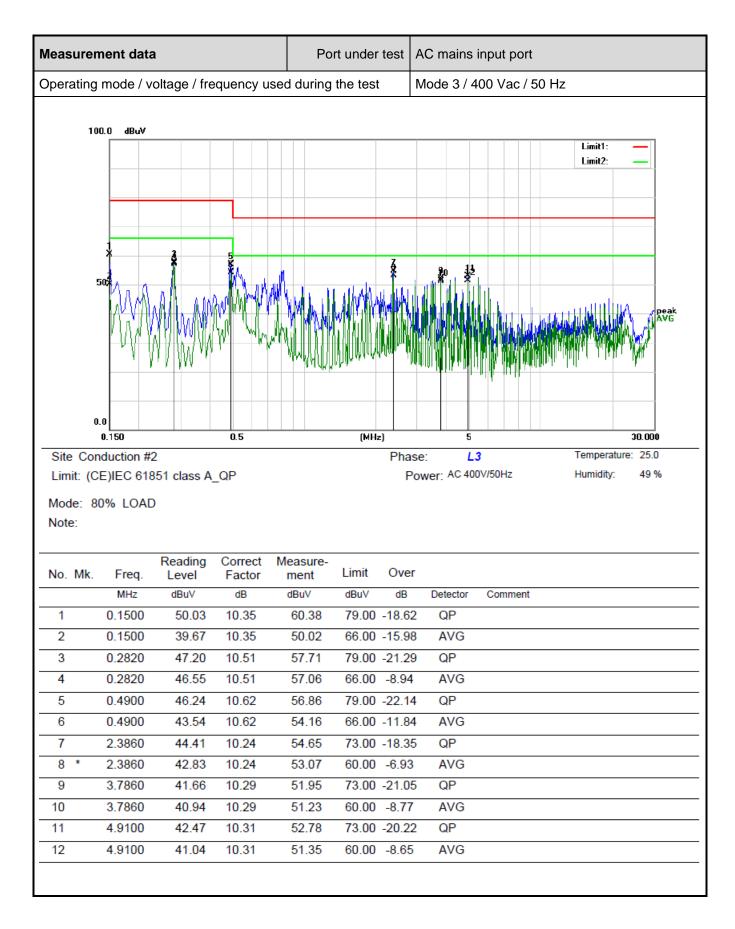
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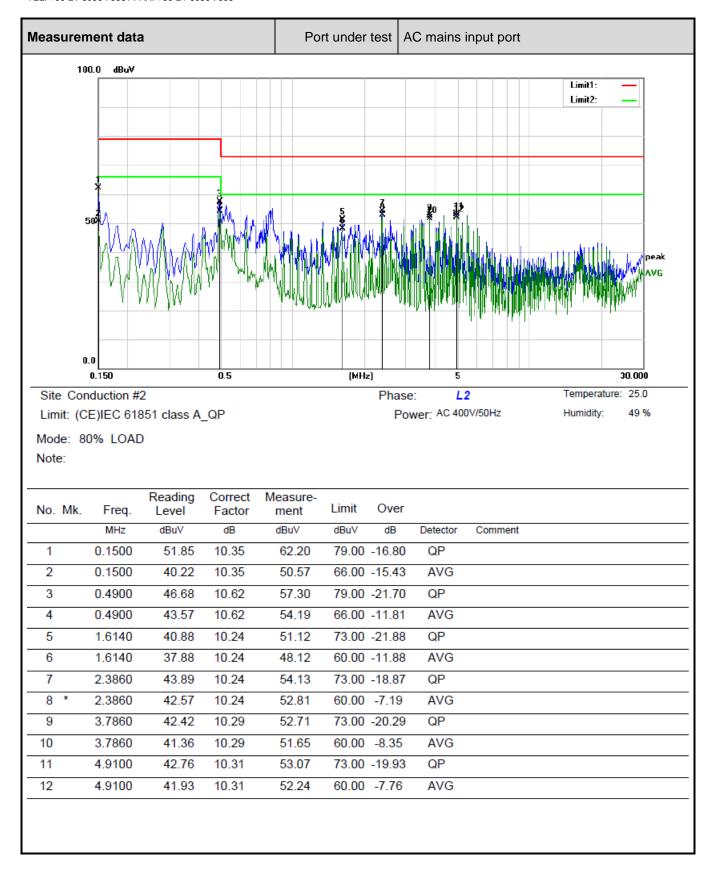
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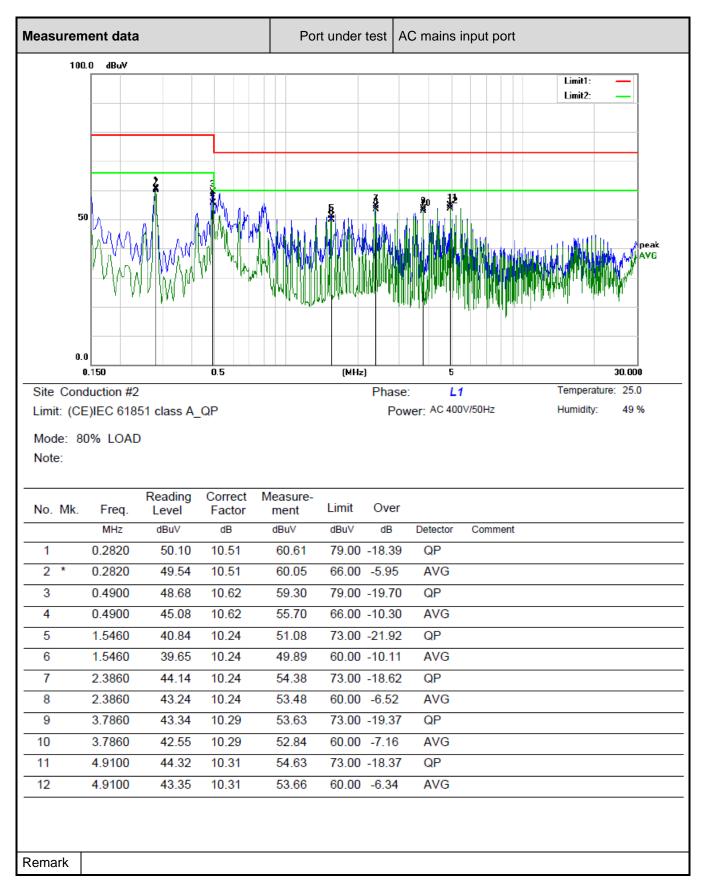
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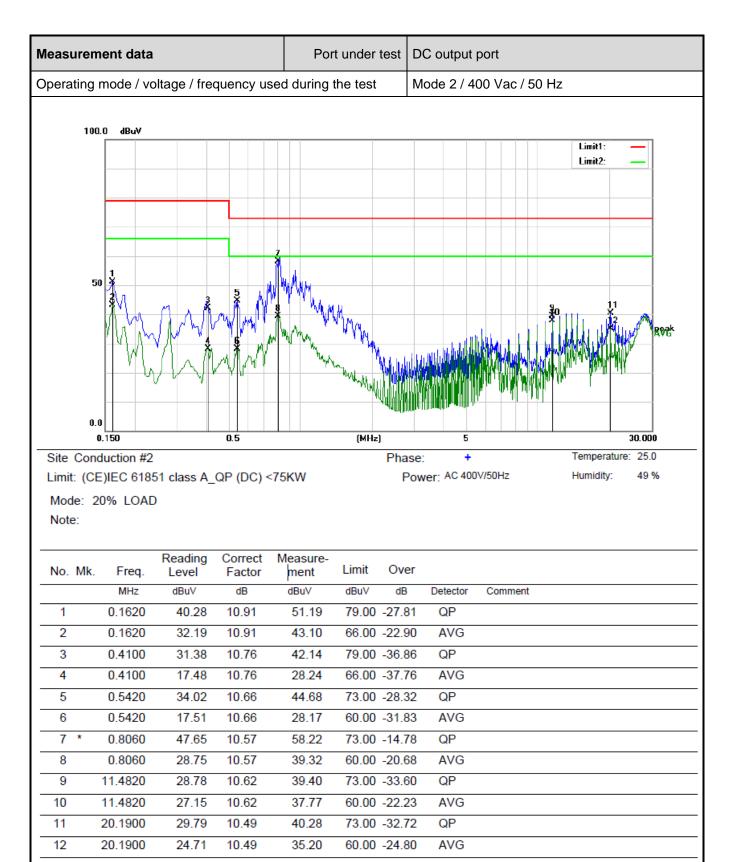
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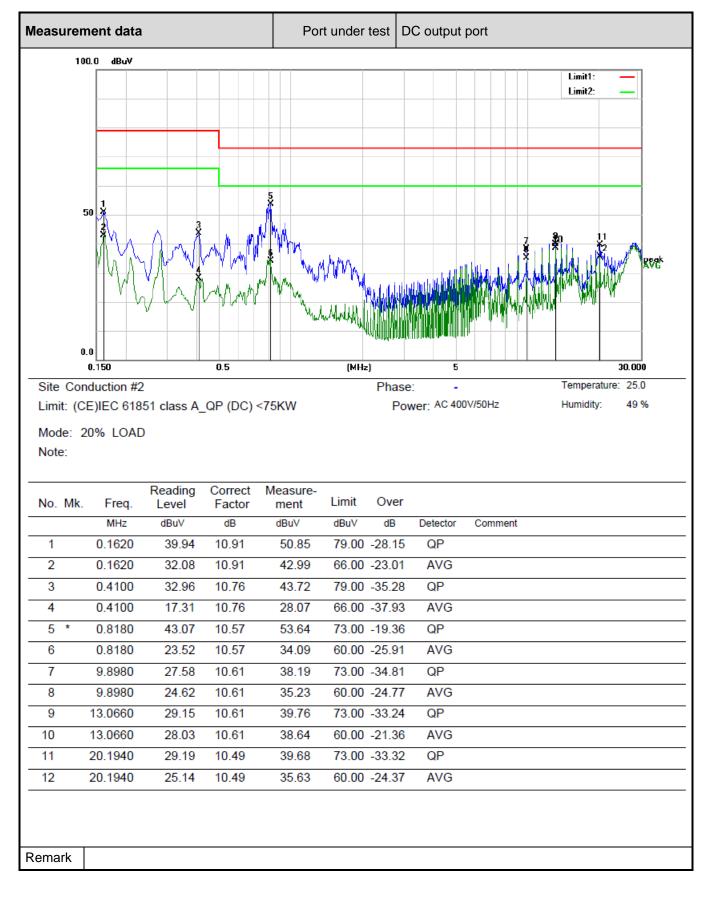
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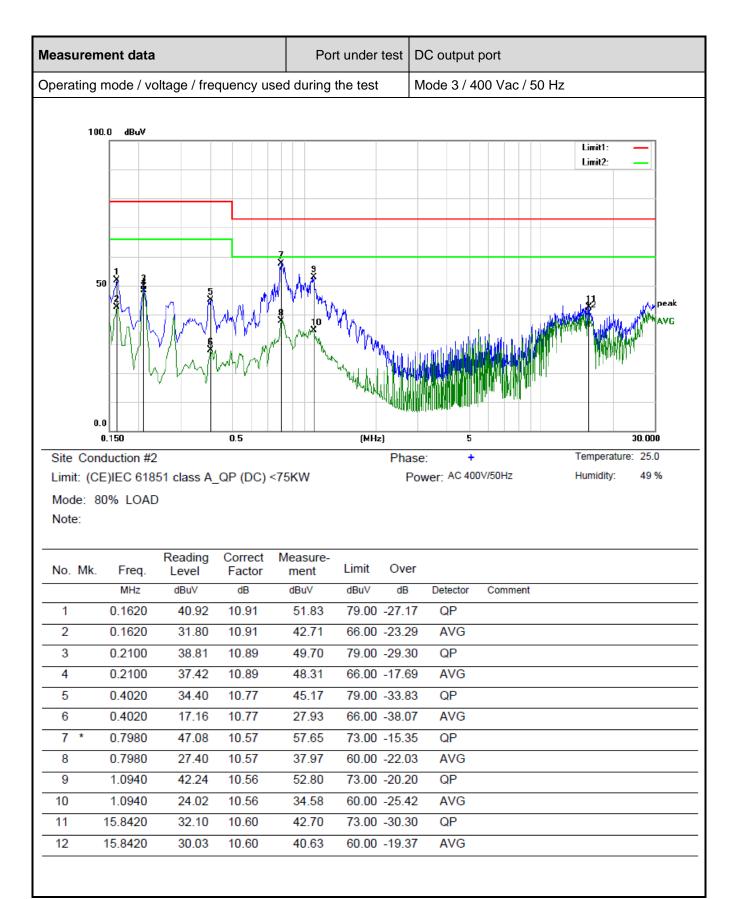
Zhabei District Shanghai 200436 China





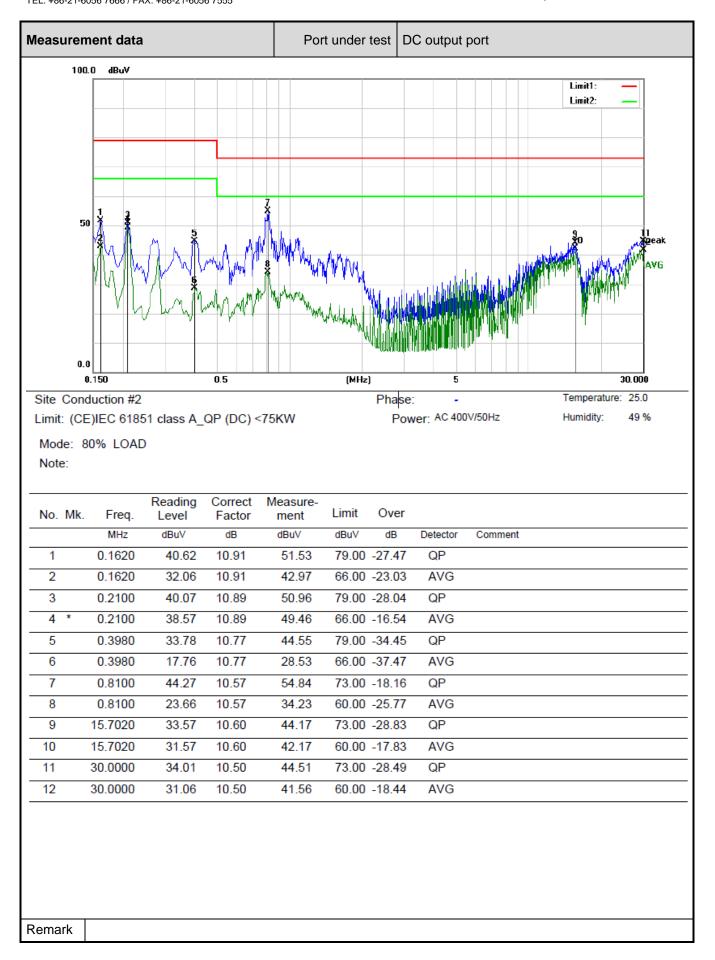
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PASS

# 4.2 Asymmetric mode conducted emissions VERDICT:

Standard	IEC 61851-21-2
Basic standard(s)	CISPR 16-2-1

### Limits – Class A

Fraguanay	Coupling device							
Frequency range	AAN		CVP		Current Probe		IF BW	Detector(s)
[MHz]	Limit: QP	Limit: AV	Limit: QP	Limit: AV	Limit: QP	imit: QP Limit: AV		
	[dB(µV) <sup>1)</sup> ]	[dB(µV) <sup>1)</sup> ]	[dB(µV) <sup>1)</sup> ]	[dB(µV) 1)]	[dB(µA) <sup>1)</sup> ]	[dB(µA) 1)]		
0,15 - 0,50	97 – 87 <sup>2)</sup>	84 – 74 <sup>2)</sup>	97 – 87 <sup>2)</sup>	84 – 74 <sup>2)</sup>	53 – 43	40-30	9 KHz	QP, CAV
0,50 - 30	87	74	74 87 74 43 74		74	9 KHz	QP, CAV	
<sup>1)</sup> At the transition frequency, the lower limit applies.								
<sup>2)</sup> The limit decre	ases linearly w	ith the logarith	nm of the freque	ency.				

### Limits – Class B

	Coupling device							
Frequency range	AA	AAN		CVP		Current Probe		Detector(s)
[MHz]	Limit: QP	Limit: AV	Limit: QP	Limit: QP Limit: AV Limit: QP Limit:		Limit: AV		
	[dB(µV) <sup>1)</sup> ]	[dB(µV) 1)]	[dB(µV) <sup>1)</sup> ]	[dB(µV) 1)]	[dB(µA) <sup>1)</sup> ]	[dB(µA) 1)]		
0,15 - 0,50	84 – 74 <sup>2)</sup>	74 – 64 <sup>2)</sup>	84 – 74 <sup>2)</sup>	74 – 64 <sup>2)</sup>	40– 30	30– 20	9 KHz	QP, CAV
0,50 - 30	74 64 74 64 30 20				9 KHz	QP, CAV		
<sup>1)</sup> At the transition frequency, the lower limit applies.								
<sup>2)</sup> The limit decre	ases linearly w	ith the logarith	nm of the freque	ency.				



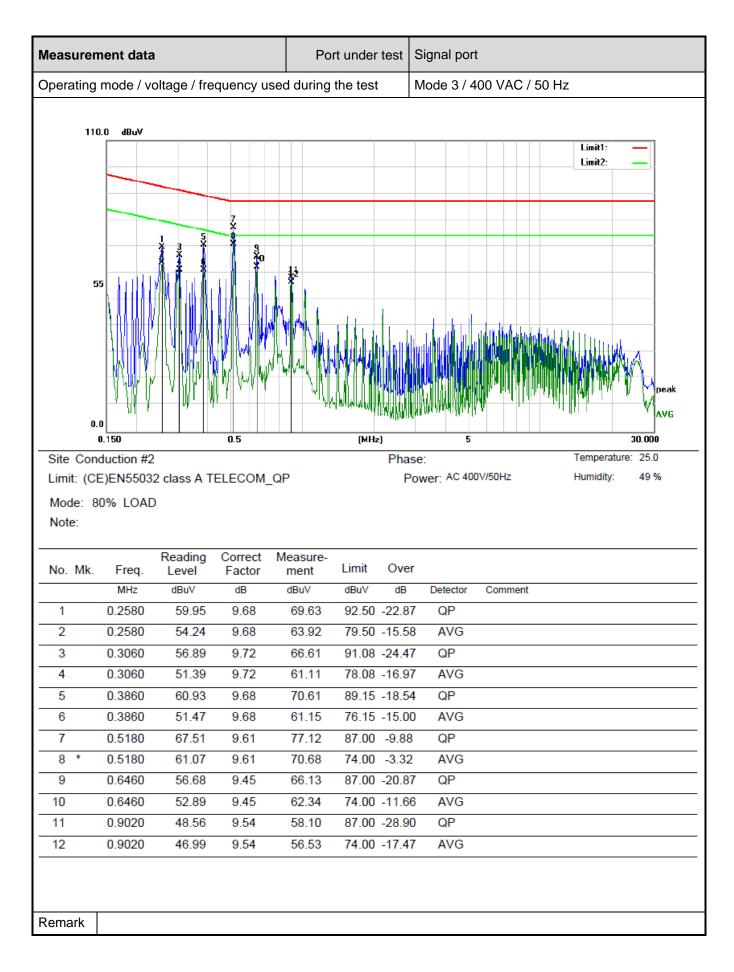
### Performed measurements

Port	under test							
	LAN / Ethernet			$\square$	Other: Signal			
	Other:				Other:			
Voltage – Mains [V] 400 Vac			/ac					
Freq	uency – Mains [Hz]	50Hz						
Test	method applied		ISN – Impedance S	tabilisa	ation Network			
			CDN according to EN / IEC 61000-4-6					
			Voltage probe					
			Current probe					
			Artificial mains netw	ork				
			Other:					
		$\square$	Table top		Artificial hand applied			
Test	Test setup		Floor standing		Other:			
Refer to the Annex 3 for te				est setu	up photo(s).			
Operating mode(s) used Mode 2, Mode 3								
Rem	ark	All m	odes were tested, bu	t only v	worst case was recorded in report.			

See next page.

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# 4.3 Radiated electromagnetic disturbances (2 – 185 KHz & 30 – 1000 MHz)

VERDICT: PASS

Standard	IEC 61851-21-2					
Basic standard(s)	CISPR 16-2-3					
Test method	Antenna method according to CISPR 16-2-3 standard.					
Supplementary information:						
	(CISPR 11) standard Table 1 footnote b) no limits apply to the fundamental and all other within the designated band of RF product(s)/unit(s).					

### Limits – Class A equipment

Frequency	Limit: QP [d	B(μV/m) <sup>1)</sup> ]	IF BW	Detector	
[MHz]	@3 m.	@10 m.		Delector	
30 - 230	50	40	120 KHz	QP	
230 - 1000	57	47	120 KHz	QP	
<sup>1)</sup> At the transition frequency, the lowe	er limit applies.				

### Limits – Class B equipment

Frequency	Limit: QP [d	IF BW	Detector	
[MHz]	@3 m.	@10 m.		Delector
30 - 230	40	30	120 KHz	QP
230 - 1000	47	37	120 KHz	QP
<sup>1)</sup> At the transition frequency, the lowe	er limit applies.			

#### Limits

Frequency	Limit: QP [dB(µV/m) <sup>1)</sup> ]	IF BW	Detector
[kHz]	@1 m.		Delector
2 - 10	62-60	200 Hz	QP
10 - 30	60	200 Hz	QP
30 - 75	60-95	200 Hz	QP
75 - 120	95-55	200 Hz	QP
120 - 140	55	200 Hz	QP
140 - 185	55-95	200 Hz	QP
1) The limit decreases linearly with free	juency.		
2) The limit increases linearly with freq	uency.		

3) This test is applicable only to DC charging equipment



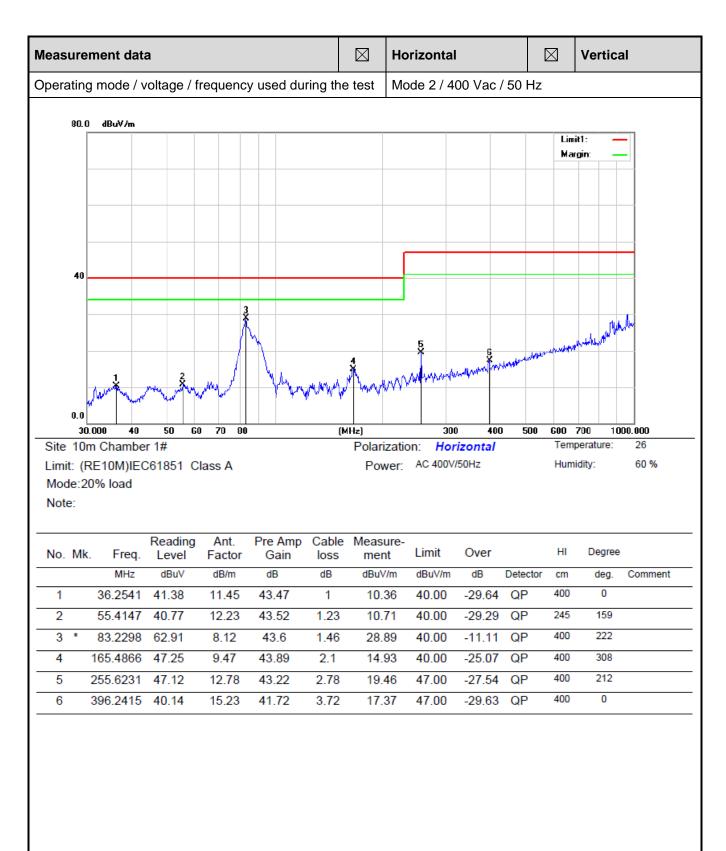
### Performed measurements

Port under test	Enclo	Enclosure					
Voltage – Mains [V]	400 \	400 Vac					
Frequency – Mains [Hz]	50Hz						
Test method applied		OATS or SAC with measurement distance [m]: 1 m.					
		OATS or SAC with measurement distance [m]: 3 m.					
	$\square$	OATS or SAC with measurement distance [m]: 10 m.					
Test setup		Equipment on a table of 80 cm height					
		Equipment on the floor (insulated from ground plane)					
		Other:					
	Refer	to the Annex 3 for test setup photo(s).					
Operating mode(s) used	Mode	2, Mode 3					
Remark	For 2	- 185 KHz, all modes were tested but only worst case was recorded in report.					

See next page.

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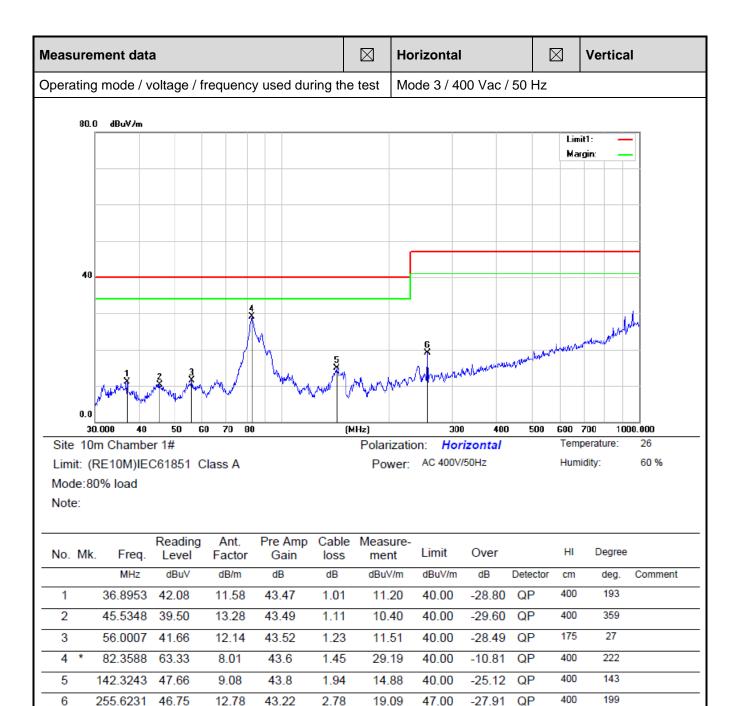
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	ent data	a				🛛 🛛 Ho	rizontal			$\square$	Vert	ical	
perating i	mode / v	oltage / f	requency	y used du	ring the t	test Mo	de 2 / 40	)0 Vac /	50 Hz				
80.0	dBuV/m												
										Lim Mar	iit1: rgin:		
-													
_													
						[							
40			4										
			$\square$	VÅ –									
			. /	11	6					MARY	WWW	and M.	
	2		3		. My Mith	<u>ц</u>			Marthungh	~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~			
- M	WA.	a m. Marcal	f may	Mart	www.wh	the work	househow	by industrial and a second					
	Manuel .					mark.							
0.0								100	<b>F00</b>	000	700	1000.0	
30.00 Site 10m Limit: (RE Mode:209	Chambe 10M)IEC	<u>50 60</u> r 1# C61851 C			(мн	Polarizatio	300 0n: Vert AC 400V/	ical	500		700 perature iidity:		<b>00</b> 26 60 %
30.00 Site 10m Limit: (RE Mode:209	Chambe 10M)IEC	r 1# C61851 C	lass A			Polarizatio Power:	on: Vert	ical	500	Tem	perature	e: 2	26
30.00 Site 10m Limit: (RE Mode:209 Note:	Chambe 10M)IEC	r 1#				Polarizatio	on: Vert	ical	500	Tem	perature	e: 2 6	26
30.00 Site 10m Limit: (RE Mode:209 Note: Note:	Chambe E10M)IEC % load Freq. MHz	r 1# C61851 C Reading Level dBuV	Ant. Factor	Pre Amp Gain dB	Cable loss dB	Polarizatio Power: Measure- ment dBuV/m	AC 400V/ AC 400V/ Limit dBuV/m	tical 50Hz Over dB	Detector	Tem Hum HI cm	perature iidity: Deg de	e: 2 6 jree	26
30.00 Site 10m Limit: (RE Mode:209 Note: Note: No. Mk.	Chambe E10M)IEC % load Freq. MHz 31.0706	r 1# C61851 C Reading Level dBuV 49.22	Ant. Factor dB/m 10.47	Pre Amp Gain dB 43.27	Cable loss dB 1.28	Polarizatic Power: Measure- ment dBuV/m 17.70	Dn: Vert AC 400V/ Limit dBuV/m 40.00	tical 50Hz Over dB -22.30	Detector	Tem Hum HI cm 199	perature iidity: Deg de 28	e: 2 6 jree g. Co 37	26 60 %
30.00 Site 10m Limit: (RE Mode:209 Note: No. Mk. 1 : 2 :	Chambe E10M)IEC % load Freq. MHz 31.0706 35.6240	r 1# C61851 C Reading Level dBuV 49.22 46.86	Ant. Factor dB/m 10.47 11.2	Pre Amp Gain dB 43.27 43.28	Cable loss dB 1.28 1.37	Polarizatio Power: Measure- ment dBuV/m 17.70 16.15	Dn: Vert AC 400V/ Limit dBuV/m 40.00 40.00	Cover dB -22.30 -23.85	Detector QP QP	Tem Hum HI cm 199	perature iidity: Deg de 28	e: 2 6 jree ig. Co 37	26 60 %
30.00 Site 10m Limit: (RE Mode:209 Note: No. Mk. 1 3 6	Chambe E10M)IEC % load Freq. MHz 31.0706 35.6240 65.3432	r 1# C61851 C Reading Level dBuV 49.22 46.86 49.87	Ant. Factor dB/m 10.47 11.2 12.32	Pre Amp Gain dB 43.27 43.28 43.35	Cable loss dB 1.28 1.37 1.83	Polarizatio Power: Measure- ment dBuV/m 17.70 16.15 20.67	Dn: Vert AC 400V/ Limit dBuV/m 40.00 40.00	Cover dB -22.30 -23.85 -19.33	Detector QP QP QP	Tem Hum HI cm 199 101	perature iidity: Deg de 28 19 7	e: 2 6 gree eg. Co 37 92	26 60 %
30.00 Site 10m Limit: (RE Mode:209 Note: Note: No. Mk. 1 3 2 3 3 0 4 * 3	Chambe E10M)IEC % load Freq. MHz 31.0706 35.6240 65.3432 82.3588	r 1# C61851 C Reading Level dBuV 49.22 46.86 49.87 68.13	Ant. Factor dB/m 10.47 11.2 12.32 9.12	Pre Amp Gain dB 43.27 43.28 43.35 43.39	Cable loss dB 1.28 1.37 1.83 2.04	Polarizatic Power: Measure- ment dBuV/m 17.70 16.15 20.67 35.90	Dn: Vert AC 400V/ Limit dBuV/m 40.00 40.00 40.00	Cover dB -22.30 -23.85 -19.33 -4.10	Detector QP QP QP	Tem Hum HI cm 199 109 101	perature iidity: Deg de 28 79 79 70 22	e: 2 6 gree eg. Co 37 92 9	26 60 %
30.00 Site 10m Limit: (RE Mode:209 Note: Note: No. Mk. 1 3 2 3 3 0 4 * 8 5 9	Chambe E10M)IEC % load Freq. MHz 31.0706 35.6240 65.3432	r 1# C61851 C Reading Level dBuV 49.22 46.86 49.87 68.13 64.75	Ant. Factor dB/m 10.47 11.2 12.32	Pre Amp Gain dB 43.27 43.28 43.35	Cable loss dB 1.28 1.37 1.83	Polarizatio Power: Measure- ment dBuV/m 17.70 16.15 20.67	Dn: Vert AC 400V/ Limit dBuV/m 40.00 40.00	Cover dB -22.30 -23.85 -19.33	Detector QP QP QP QP QP	Tem Hum HI cm 199 101	perature iidity: Deg de 28 7 7 22 33	e: 2 6 gree eg. Co 37 92	26 60 %

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	ment data	1					orizontal			$\boxtimes$	Verti	cal	
Dperating mode / voltage / frequency used during the						test M	Mode 3 / 400 Vac / 50 Hz						
80.0	dBuV/m												
											nit1: Irgin:		
-													
-													
_													
40 -			X										
ŀ			┤	. Å			1						
			2	M.	6						allowed to all and	where a	
2	×		Ă/		۰.ľ				. and walk	No. All Marker			
	Warne	. M. I	nw	M	M 4	M	Municipality	WWW Andrew	www.				
-	man marked	my phane		·γγ		way why	W LANNAM T						
0.0													
30.	.000 40	50 60	) 70 80		(M	Hz)	300		) 500	600		1000.000	
	m Chambe RE10M)IEC 0% load	r 1#	lass A			Polarizat Power	ion: <b>Ver</b> : AC 400V	<b>tical</b> /50Hz			perature hidity:	e: 26 60%	
Limit: (R Mode:80 Note:	RE10M)IEC 0% load	r 1# C61851 Cl Reading	Ant.	Pre Amp		Power	AC 400V	/50Hz		Hum	nidity:	60 %	
Limit: (R Mode:80 Note:	RE10M)IEC 0% load	r 1# 61851 Cl		Pre Amp Gain dB	Cable loss dB	Power	AC 400V		Detector	Hum	-	60 % ree	
Limit: (R Mode:80 Note:	RE10M)IEC 0% load . Freq.	r 1# C61851 Cl Reading Level dBuV	Ant. Factor	Gain	loss	Power Measure ment	: AC 400V/	/50Hz Over		Hum	nidity: Degr	60 % ree g. Comment	
Limit: (R Mode:80 Note: No. Mk.	RE10M)IEC 0% load . Freq. MHz	r 1# C61851 Cl Reading Level dBuV 53.95	Ant. Factor dB/m	Gain dB	loss dB	Power Measure ment dBuV/m	AC 400V	/50Hz Over dB	QP	Hum	nidity: Degr deg	60 % ree g. Comment 4	
Limit: (R Mode:80 Note: No. Mk.	RE10M)IEC 0% load . Freq. MHz 30.8535	r 1# C61851 Cl Reading Level dBuV 53.95 52.92	Ant. Factor dB/m 10.44	Gain dB 43.27	dB 1.28	Power Measure ment dBuV/m 22.40	AC 400V/	/50Hz Over dB -17.60	QP	Hum HI cm 100	Degr deg 274	60 % ree g. Comment 4	
Limit: (R Mode:80 Note: No. Mk.	RE10M)IEC 0% load . Freq. MHz 30.8535 65.1145	r 1# 661851 Cl Reading Level dBuV 53.95 52.92 68.97	Ant. Factor dB/m 10.44 12.37	Gain dB 43.27 43.35	loss dB 1.28 1.83	Power Measure ment dBuV/m 22.40 23.77	AC 400V/	/50Hz Over dB -17.60 -16.23	QP QP	Hum HI cm 100	Degr deg 274 128	60 % ree g. Comment 4 8 9	
Limit: (R Mode:80 Note: No. Mk. 1 2 3 * 4	RE10M)IEC 0% load Freq. MHz 30.8535 65.1145 81.7833	r 1# C61851 Cl Reading Level dBuV 53.95 52.92 68.97 63.32	Ant. Factor dB/m 10.44 12.37 9.19	Gain dB 43.27 43.35 43.39	loss dB 1.28 1.83 2.03	Power Measure ment dBuV/m 22.40 23.77 36.80	AC 400V/ Limit dBuV/m 40.00 40.00	/50Hz Over dB -17.60 -16.23 -3.20	QP QP QP QP	Hum HI cm 100 199 199	Degr deg 274 128 229	60 % ree g. Comment 4 8 9 5 3	

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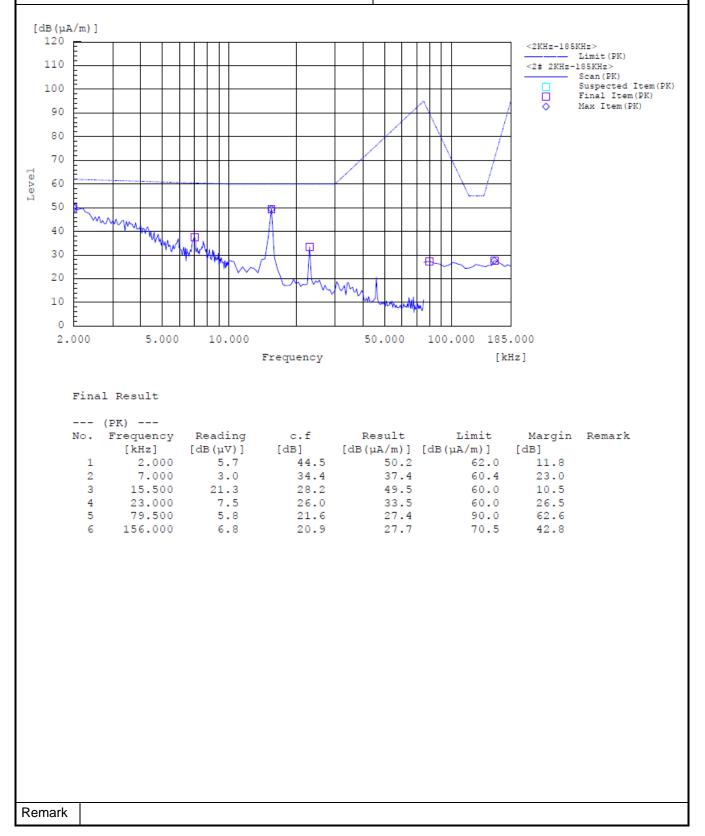
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Operating mode / voltage / frequency used during the test Mod

test Mode 3 / 400 Vac / 50 Hz





# 4.4 Radiated electromagnetic disturbances (above 1 GHz)

VERDICT: N/A

Standa	ard	IEC 61851-21-2				
Basic s	standard(s)	CISPR 16-2-3				
Test m	ethod	Antenna method according to	CISPR 16-2-3 standard.			
		Required highest frequency for	radiated measurement			
	Highest interna	al frequency [fx]	Highest measured frequency			
$\boxtimes$	f <sub>x</sub> :	≤ 108 MHz	1 GHz			
	108 MH:	z < f <sub>x</sub> ≤ 500 MHz	2 GHz			
	500 MI	Hz < f <sub>x</sub> ≤ 1 GHz	5 GHz			
	f,	<sub>α</sub> ≥1 GHz	5x f <sub>x</sub> or up to 6 GHz			

### Limits - Class A equipment

Frequency	@3	3 m	@1	0 m.		
[MHz]	Limit: PK [dB(µV/m) <sup>1)</sup> ]	Limit: AV [dB(µV/m) <sup>1)</sup> ]	Limit: PK [dB(µV/m) <sup>1)</sup> ]	Limit: AV [dB(µV/m) <sup>1)</sup> ]	IF BW	Detector
1 - 3	76	56	66	46	1 MHz	PK, CAV
3 - 6	80	60	70	50	1 MHz	PK, CAV
<sup>1)</sup> At the transition frequency, the lo	ower limit applies.					

### Limits - Class B equipment

Frequency	@3	3 m	@1			
[MHz]	Limit: PK [dB(µV/m) <sup>1)</sup> ]	Limit: AV [dB(µV/m) <sup>1)</sup> ]	Limit: PK [dB(µV/m) <sup>1)</sup> ]	Limit: AV [dB(µV/m) <sup>1)</sup> ]	IF BW	Detector
1 - 3	70	50	60	40	1 MHz	PK, CAV
3 - 6	74	54	64	44	1 MHz	PK, CAV
<sup>1)</sup> At the transition frequency, the l	ower limit applies.					

### **Performed measurements**

Port under test		
Voltage – Mains [V]		
Frequency – Mains [Hz]		
Test method applied		Absorber-lined OATS or SAC with measurement distance [m]: 3 m.
		Absorber-lined OATS or SAC with measurement distance [m]: 1 m.
Test setup		Equipment on a table of 80 cm height
		Equipment on the floor (insulated from ground plane)
		Other:
	Refe	r to the Annex 3 for test setup photo(s).
	1	
Operating mode(s) used		
Remark		
See next page.	1	

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Measurement data		Horizontal	Vertical
Operating mode / voltage / frequency used during the	he test		
Highest internal frequency of the EUT $\leq$ 108MHz, so it no	need to	perform the test item.	
Remark			



# 4.5 Harmonic current emissions

# VERDICT: PASS

Standard	IEC 61851-21-2			IEC 61851-21-2		
Basic standard	IEC 61	IEC 61000-3-2&12				
Exlusions		Arc welding equipment intended for professional use.				
(For these categories of		System(s) with nominal voltage(s) less than 220 $V_{AC}$ (line-to-neutral).				
equipment, limits are not		Equipment with rated power of $\leq 75$ W (other than lighting equipment).				
specified in the EN 61000- 3-2 standard)		Professional equipment with total rated power > 1 kW.				
,		Symmetrically controlled heating elements with a rated power $\ge$ 200 W.				
		Independent dimmers for incandescent lamps with rated power $\leq$ 1 kW.				

Classific	cation ( $I_{input} \leq 16 A$ )						
	Class A	All app	All apparatus not classified as Class B, C or D				
	Class B	Portab	Portable tools				
			Lighting equipment with active input power > 25 W				
	Class C		Lighting equipment with active input power ≤ 25 W				
	01035 0	(First requirement, Table 3 column 2)					
		□ Lighting equipment with active input power $\leq$ 25 W (Second requirement)					
	Class D	Personal computers, television receivers					

Classific	Classification ( $16 \text{ A} \leq I_{input} < 75 \text{ A}$ )					
	Table 2         other than balanced three-phase equipment					
$\boxtimes$	Table 3	balanced three-phase equipment				
	Table 4	balanced three-phase equipment under specified conditions (a,b,c)				
	Table 5	balanced three-phase equipment under specified conditions (d,e,f)				

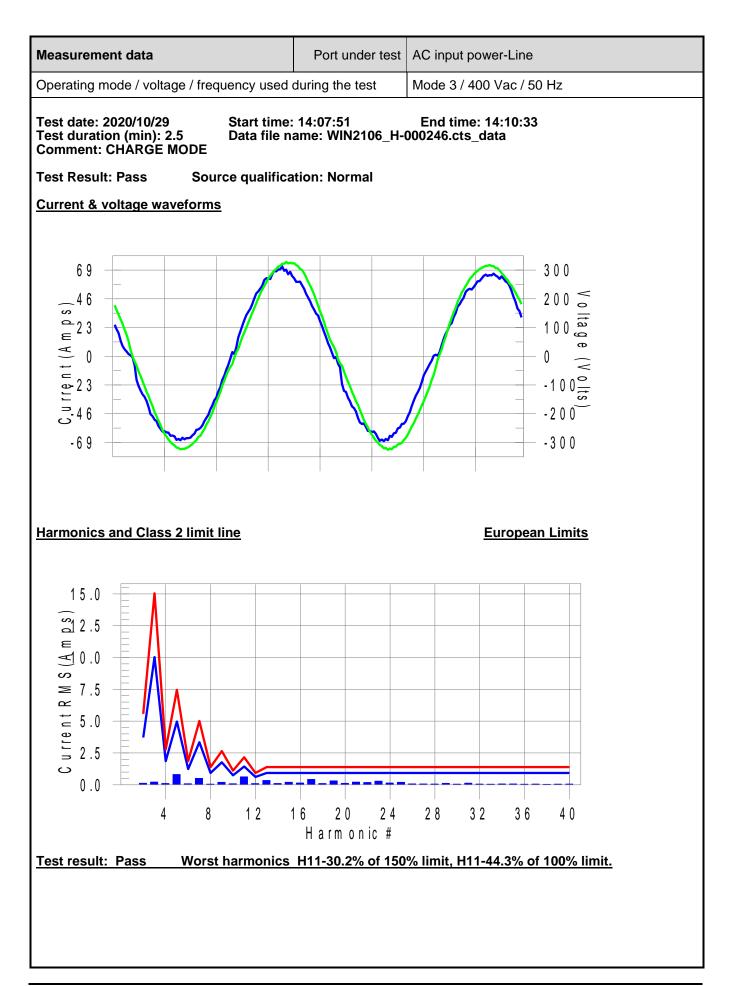


# Performed measurements

Port under test	AC ma	AC mains power input					
Voltage – Mains [V]	400 Va	00 Vac					
Frequency – Mains [Hz]	50Hz	i0Hz					
Observation peroid		□ 6.5 min. ⊠ 2.5 min. □ Other:					
Version of measurement	$\square$	EN 61000-4-7:2002 + AM1:2009 (IEC 61000-4-7:2002+AM1:2008)					
instrument standard used EN / IEC61000-4-7 (Cl. 7)		EN 61000-4-7:1991					
		Comply with the	e require	ements of the Claus	se 6.1 (E	EN / IEC 61000-3-2).	
Control principle used in	$\square$	Comply with the requirements of the Clause 6.1 (EN / IEC 61000-3-12).					
the EUT		Not comply with	the rea	quirements of the C	lause 6.	1 (EN / IEC 61000-3-2).	
		Not comply with the requirements of the Clause 6.1 (EN / IEC 61000-3-12).					
Operating mode(s) used Mode 3							
Remark		Mode 3					

See next page.







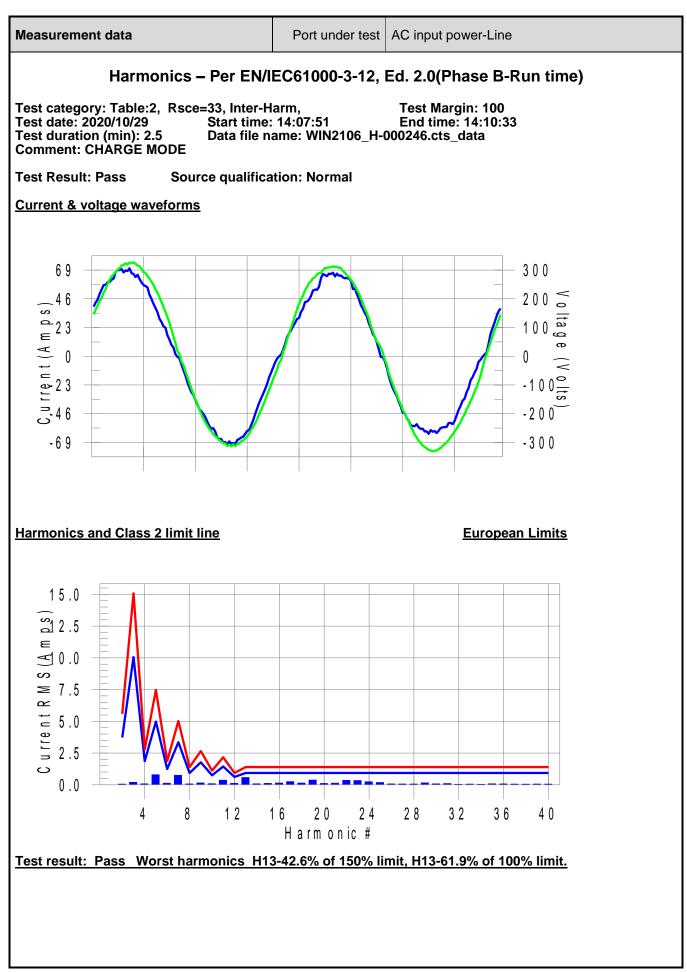
Measurement data	P	ort under test	AC input power-Line			
Current T	est Resul	t Summary (	Phase A-R	un time)		
	rt time: 14:0		Test Margir End time: 1 )0246.cts_da	4:10:33		
Test Result: Pass Measur THC/Iref (%): 2.5 Limit (%): 23.0	ed Iref: 46.4 0 PWH	l38(Amps) C/Iref (%):  0.0		rce: Norma imit (%): 23		
Highest parameter values during f V_RMS (Volts): 230.33 I_Peak (Amps): 75.074 I_Fund (Amps): 46.352(av Power (Watts): 10617		Frequency (Hz I_RMS (Amps) Crest Factor: Power Factor:	: 46.473 1.617			
Harm# Harms(avg) 100%Limit	%of Limit	Harms(max)	150%Limit	%of Limit	Status	
Harm#Harms(avg)100%Limit2 $0.131$ $3.715$ 3 $0.226$ $10.031$ 4 $0.113$ $1.858$ 5 $0.818$ $4.969$ 6 $0.092$ $1.238$ 7 $0.513$ $3.344$ 8 $0.058$ $0.929$ 9 $0.208$ $1.765$ 10 $0.093$ $0.743$ 11 $0.638$ $1.440$ 12 $0.100$ $0.619$ 13 $0.348$ $0.929$ 14 $0.111$ N/A15 $0.212$ N/A16 $0.147$ N/A17 $0.428$ N/A18 $0.105$ N/A19 $0.319$ N/A20 $0.126$ N/A21 $0.218$ N/A23 $0.296$ N/A24 $0.146$ N/A	%of Limit 3.5 2.3 6.1 16.5 7.4 15.4 6.2 11.8 12.6 44.3 16.1 37.5 N/A N/A N/A N/A N/A N/A N/A N/A N/A N/A	Harms(max) 0.153 0.263 0.126 0.863 0.101 0.539 0.069 0.222 0.104 0.652 0.117 0.362 0.124 0.222 0.160 0.443 0.123 0.322 0.147 0.261 0.225 0.328 0.167	5.573 15.046 2.786 7.453 1.858 5.015 1.393 2.647 1.115 2.159 0.929 1.393 N/A N/A N/A N/A N/A N/A N/A N/A N/A N/A	% of Limit 2.7 1.7 4.5 11.6 5.4 10.7 5.0 8.4 9.3 30.2 12.6 26.0 N/A N/A N/A N/A N/A N/A N/A N/A N/A N/A	Status Pass Pass Pass Pass Pass Pass Pass Pa	
24         0.146         N/A           25         0.206         N/A           26         0.074         N/A           27         0.068         N/A           28         0.065         N/A           29         0.123         N/A           30         0.058         N/A           31         0.139         N/A           32         0.060         N/A           33         0.054         N/A           34         0.068         N/A           35         0.068         N/A           36         0.053         N/A           37         0.062         N/A           38         0.048         N/A           39         0.055         N/A	N/A N/A N/A N/A N/A N/A N/A N/A N/A N/A	0.167 0.222 0.087 0.078 0.072 0.134 0.068 0.148 0.067 0.061 0.074 0.076 0.059 0.068 0.067 0.069 0.071	N/A N/A N/A N/A N/A N/A N/A N/A N/A N/A	N/A N/A N/A N/A N/A N/A N/A N/A N/A N/A	N/A N/A N/A N/A N/A N/A N/A N/A N/A N/A	

Note: Measured I-ref was applied for this test.



Measurement data		Port un	der test AC inpu	ut power-Line				
Voltage Source Verification Data (Phase A-Run time)								
Test date: 2020/10/29 Test duration (min): 2	Test category: Table:2, Rsce=33, Inter-Harm,Test Margin: 100Test date: 2020/10/29Start time: 14:07:51End time: 14:10:33Test duration (min): 2.5Data file name: WIN2106_H-000246.cts_dataComment: CHARGE MODE							
Test Result: Pass Source qualification: Normal Measured source distortion is within the requirements of the standards Measurements are compliant with IEC/EN61000-3-12 Ed. 2.0 & IEC/EN61000-4-7 Ed. 2.1								
Highest parameter values during test:Voltage (Vrms):230.33Frequency (Hz):50.00I_Peak (Amps):75.074I_RMS (Amps):46.473I_Fund (Amps):46.352(avg)Crest Factor:1.617Power (Watts):10617Power Factor:0.992								
Harm# Harmoni	cs V-rms Li	imit V-rms	% of Limit	Status				
2 3 4 5 6 7 8 9 10 11 12 13 14 15 16 17 18 19 20 21 22 23 24 25 26 27 28 29 30 31	0.319 0.346 0.200 0.177 0.150 0.159 0.119 0.307 0.135 0.304 0.123 0.188 0.120 0.184 0.120 0.184 0.120 0.184 0.154 0.300 0.121 0.255 0.148 0.172 0.160 0.283 0.106 0.251 0.115 0.139 0.123 0.225 0.087 0.222	0.921 2.878 0.921 3.454 0.921 2.878 0.921 1.382 0.921 1.612 0.691 1.381 0.691 0.691 0.691 0.691 0.691 0.691 0.691 0.691 0.691 0.691 0.691 0.691 0.691 0.691 0.691 0.691 0.691	34.61 12.04 21.70 5.13 16.28 5.53 12.89 22.21 14.64 18.89 17.88 13.61 17.42 26.69 22.23 43.37 17.57 36.91 21.36 24.95 23.15 41.01 15.41 36.28 16.69 20.11 17.82 32.59 12.62 32.11	<b>ŎŎŎŎŎŎŎŎŎŎŎŎŎŎŎŎŎŎŎŎŎŎŎŎŎŎŎŎŎŎŎŎŎŎŎŎŎ</b>				
32 33 34 35 36 37 38 39 40	0.107 0.118 0.124 0.145 0.089 0.149 0.083 0.099 0.104	0.691 0.691 0.691 0.691 0.691 0.691 0.691 0.691 0.691	15.45 17.14 17.89 21.05 12.91 21.63 12.03 14.38 15.08	ОК ОК ОК ОК ОК ОК				







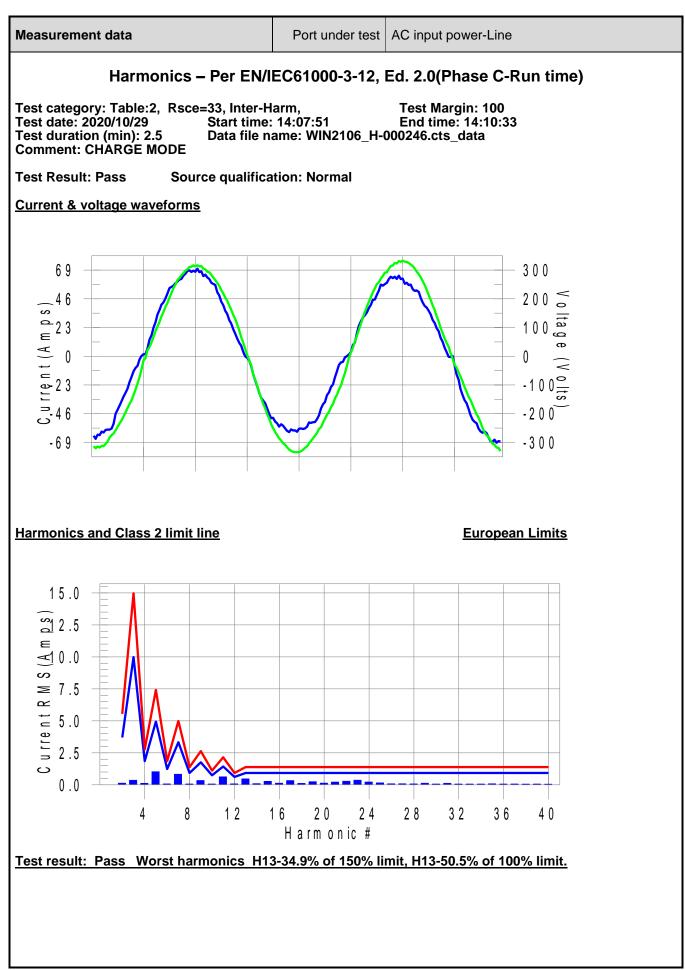
Measurement data			F	Port under test	AC input pow	er-Line			
		Current To	est Resu	It Summarv	(Phase B-R	un time)			
	Current Test Result Summary (Phase B-Run time)								
Test da Test du	tegory: Table:2 te: 2020/10/29 iration (min): 2 ent: CHARGE I	Star .5 Data	t time: 14:		Test Margir End time: 1 000246.cts_da	4:10:33			
	esult: Pass ef (%): 2.7  L	Measur imit (%): 23.0		.554(Amps) IC/Iref (%):  0.0		ırce: Norma imit (%): 23			
Highest parameter values during test:									
_	V_RMS (Volts)			Frequency (H					
	I_Peak (Amps) I_Fund (Amps)		a)	I_RMS (Amps Crest Factor:					
	Power (Watts)	: 10627	9)	Power Factor					
Harm#	Harms(avg)	100%Limit	%of Limit	Harms(max)	150%Limit	%of Limit	Status		
2	0.055	3.724	1.5	0.070	5.586	1.3	Pass		
3	0.196	10.056	2.0	0.227		1.5	Pass		
4	0.080	1.862	4.3	0.093	2.793	3.3	Pass		
5 6	0.800	4.981	16.1	0.820		11.0	Pass		
6	0.130	1.241	10.5	0.143		7.7	Pass		
7	0.755	3.352	22.5	0.771		15.3	Pass		
8 9	0.072	0.931	7.7	0.084		6.0	Pass		
9 10	0.147 0.094	1.769 0.745	8.3 12.6	0.170 0.102		6.4 9.2	Pass Pass		
11	0.368	1.443	25.5	0.378		9.2 17.5	Pass		
12	0.115	0.621	18.5	0.126		13.5	Pass		
13	0.577	0.931	61.9	0.595		42.6	Pass		
14	0.086	N/A	N/A	0.097		N/A	N/A		
15	0.117	N/A	N/A	0.153		N/A	N/A		
16	0.142	N/A	N/A	0.155		N/A	N/A		
17	0.258	N/A	N/A	0.272		N/A	N/A		
18	0.143	N/A	N/A	0.185		N/A	N/A		
19 20	0.379 0.106	N/A N/A	N/A N/A	0.394 0.142		N/A N/A	N/A N/A		
20	0.136	N/A	N/A	0.142		N/A	N/A		
22	0.362	N/A	N/A	0.394		N/A	N/A		
23	0.343	N/A	N/A	0.438		N/A	N/A		
24	0.249	N/A	N/A	0.275		N/A	N/A		
25	0.184	N/A	N/A	0.194		N/A	N/A		
26	0.071	N/A	N/A	0.081	N/A	N/A	N/A		
27	0.066	N/A	N/A	0.076		N/A	N/A		
28	0.061	N/A	N/A	0.068		N/A	N/A		
29 30	0.151 0.074	N/A N/A	N/A N/A	0.158 0.085		N/A N/A	N/A N/A		
30 31	0.074	N/A N/A	N/A	0.085		N/A	N/A N/A		
32	0.049	N/A	N/A	0.057		N/A	N/A		
33	0.057	N/A	N/A	0.067		N/A	N/A		
34	0.048	N/A	N/A	0.056	N/A	N/A	N/A		
35	0.082	N/A	N/A	0.093		N/A	N/A		
36	0.069	N/A	N/A	0.082		N/A	N/A		
37	0.058	N/A	N/A	0.069		N/A	N/A		
38	0.051	N/A	N/A	0.060		N/A	N/A		
39 40	0.063 0.058	N/A N/A	N/A	0.071	N/A N/A	N/A N/A	N/A N/A		
40	0.000	IN/A	N/A	0.064	N/A	IN/A	IN/A		

Note: Measured I-ref was applied for this test.



Measurement data		Port under tes	AC input pow	ver-Line		
Vo	Itage Source \	/erification Da	ata (Phase B	-Run time)		
Test category: Table:2, Rsce=33, Inter-Harm,Test Margin: 100Test date: 2020/10/29Start time: 14:07:51End time: 14:10:33Test duration (min): 2.5Data file name: WIN2106_H-000246.cts_dataComment: CHARGE MODE						
Test Result: Pass Source qualification: Normal Measured source distortion is within the requirements of the standards Measurements are compliant with IEC/EN61000-3-12 Ed. 2.0 & IEC/EN61000-4-7 Ed. 2.1						
Highest parameter values during test:Voltage (Vrms):230.28Frequency (Hz):50.00I_Peak (Amps):76.239I_RMS (Amps):46.591I_Fund (Amps):46.426(avg)Crest Factor:1.639Power (Watts):10627Power Factor:0.992						
Harm# Harmonics	V-rms Limit	V-rms % of	f Limit St	atus		
2 3 4 5 6 7 8 9 10 11 12 13 14 15 16 17 18 19 20 21 22 23 24 25 26 27 28 29	0.319 0.326 0.204 0.165 0.129 0.277 0.152 0.294 0.163 0.159 0.161 0.319 0.124 0.194 0.147 0.178 0.170 0.294 0.126 0.162 0.162 0.162 0.162 0.162 0.156 0.204 0.156 0.204 0.127 0.139 0.239	0.921 2.877 0.921 3.453 0.921 2.878 0.921 1.381 0.921 1.611 0.691 1.381 0.691 0.691 0.691 0.691 0.691 0.691 0.691 0.691 0.691 0.691 0.691 0.691 0.691 0.691 0.691 0.691 0.691 0.691	34.62 11.32 22.14 4.77 14.00 9.62 16.55 21.27 17.65 9.86 23.28 23.10 17.95 28.03 21.25 25.74 24.65 42.53 18.22 23.40 26.07 47.14 22.58 29.56 20.80 18.43 20.08 34.54	OK OK OK OK OK OK OK OK OK OK OK OK OK O		
30 31 32 33 34 35 36 37 38 39 40	0.127 0.156 0.086 0.113 0.100 0.177 0.130 0.126 0.081 0.078 0.100	0.690 0.691 0.691 0.690 0.691 0.691 0.691 0.691 0.691 0.691	18.40 22.54 12.46 16.33 14.46 25.61 18.78 18.27 11.79 11.23 14.51	ОК ОК ОК ОК ОК ОК ОК ОК		







Measurement data Port under test AC input power-Line								
	Current Test Result Summary (Phase C-Run time)							
Test da Test du	tegory: Table: te: 2020/10/29 tration (min): 2 ent: CHARGE	Sta 2.5 Dat	rt time: 14:		Test Margir End time: 1 000246.cts_da	4:10:33		
	Test Result: PassMeasured Iref: 46.198(Amps)Source: NormalTHC/Iref (%): 3.3Limit (%): 23.0PWHC/Iref (%): 0.0PWHC Limit (%): 23.0							
Highest parameter values during test: V_RMS (Volts): 230.08 Frequency (Hz): 50.00 I_Peak (Amps): 86.195 I_RMS (Amps): 46.240								
	I_Fund (Amps Power (Watts	s): 46.056(av	vg)	Crest Factor: Power Factor	1.865			
Harm#	Harms(avg)	-	%of Limit	Harms(max)	150%Limit	%of Limit	Status	
2	0.135	3.696	3.7	0.156		2.8	Pass	
3 4	0.362 0.118	9.979 1.848	3.6 6.4	0.400 0.131		2.7 4.7	Pass Pass	
56	1.029	4.943	20.8	1.063		14.3	Pass	
6	0.072	1.232	5.8	0.086		4.7	Pass	
7	0.831	3.326	25.0	0.870		17.4	Pass	
8 9	0.064 0.342	0.924 1.756	7.0 19.5	0.074 0.357		5.4 13.5	Pass Pass	
10	0.067	0.739	9.0	0.077		7.0	Pass	
11	0.629	1.432	43.9	0.643		29.9	Pass	
12	0.075	0.616	12.1	0.092		10.0	Pass	
13	0.466	0.924	50.5	0.484		34.9	Pass	
14	0.099	N/A	N/A	0.110		N/A	N/A	
15 16	0.277 0.133	N/A N/A	N/A N/A	0.301 0.149		N/A N/A	N/A N/A	
17	0.335	N/A	N/A	0.380		N/A	N/A	
18	0.116	N/A	N/A	0.136		N/A	N/A	
19	0.252	N/A	N/A	0.268	-	N/A	N/A	
20	0.138	N/A	N/A	0.169		N/A	N/A	
21 22	0.219 0.288	N/A N/A	N/A N/A	0.238 0.339	N/A N/A	N/A N/A	N/A N/A	
23	0.368	N/A	N/A	0.339		N/A	N/A	
24	0.224	N/A	N/A	0.256	N/A	N/A	N/A	
25	0.155	N/A	N/A	0.177	N/A	N/A	N/A	
26	0.085	N/A	N/A	0.092		N/A	N/A	
27 28	0.090 0.072	N/A N/A	N/A N/A	0.103 0.086		N/A N/A	N/A N/A	
20 29	0.072	N/A	N/A	0.080	N/A	N/A	N/A N/A	
30	0.060	N/A	N/A	0.076		N/A	N/A	
31	0.125	N/A	N/A	0.134	N/A	N/A	N/A	
32	0.059	N/A	N/A	0.068		N/A	N/A	
33 34	0.062	N/A	N/A	0.071	N/A	N/A	N/A	
34 35	0.061 0.084	N/A N/A	N/A N/A	0.067 0.093		N/A N/A	N/A N/A	
36	0.059	N/A	N/A	0.065		N/A	N/A	
37	0.067	N/A	N/A	0.072	N/A	N/A	N/A	
38	0.056	N/A	N/A	0.066	N/A	N/A	N/A	
39	0.062	N/A	N/A	0.068		N/A	N/A	
40	0.052	N/A	N/A	0.060	N/A	N/A	N/A	

Note: Measured I-ref was applied for this test.



Measurement data		Port under te	est AC input pov	wer-Line	
Vo	Itage Source \	/erification [	Data (Phase C	-Run time)	
Test category: Table:2, Test date: 2020/10/29 Test duration (min): 2.5 Comment: CHARGE MC	Data file na	arm, 14:07:51 ame: WIN2106_	Test Margi End time: _H-000246.cts_d	14:10:33	
Test Result: Pass Measured source distort Measurements are comp	Source qualifica tion is within the pliant with IEC/EN	requirements of	of the standards . 2.0 & IEC/EN6 <sup>2</sup>	5 1000-4-7 Ed. 2.1	
Highest parameter values during test:Voltage (Vrms):230.08I_Peak (Amps):86.195I_Fund (Amps):86.056(avg)Crest Factor:1.865Dewar (Wetta):40.532					
Power (Watts):	10533	Power Fac	ctor: 0.991		
Harm# Harmonics	V-rms Limit	V-rms %	of Limit S	tatus	
2	0.319	0.920	34.67	ОК	
3	0.296	2.875	10.28	OK	
4	0.200 0.204	0.920 3.450	21.72 5.90	OK OK	
5 6 7	0.204 0.148	0.920	16.13	OK	
7	0.215	2.875	7.47	OK	
8	0.123	0.920	13.36	ОК	
9	0.187	1.380	13.54	OK	
10	0.124	0.920	13.51	OK	
11 12	0.277 0.118	1.610 0.690	17.18 17.08	OK OK	
13	0.267	1.380	19.33	OK	
14	0.131	0.690	19.00	ŎK	
15	0.305	0.690	44.22	ОК	
16	0.142	0.690	20.65	OK	
17	0.280	0.690	40.52	OK	
18	0.121	0.690	17.58	OK	
19 20	0.220 0.128	0.690 0.690	31.85 18.57	OK OK	
20	0.254	0.690	36.80	OK	
22	0.177	0.690	25.70	ŎK	
23	0.279	0.690	40.51	ОК	
24	0.129	0.690	18.73	OK	
25	0.212	0.690	30.70	OK	
26 27	0.108 0.103	0.690 0.690	15.64 14.99	OK OK	
28	0.140	0.690	20.24	OK	
29	0.221	0.690	32.08	ŎK	
30	0.098	0.690	14.24	ОК	
31	0.209	0.690	30.25	OK	
32	0.112	0.690	16.31	OK	
33 34	0.132 0.114	0.690 0.690	19.10 16.59	OK OK	
35	0.193	0.690	27.96	OK	
36	0.096	0.690	13.95	OK	
37	0.163	0.690	23.62	ОК	
38	0.110	0.690	15.88	OK	
39 40	0.132 0.091	0.690 0.690	19.13 13.14	OK OK	
H-5_max_phase: 258.0		le for Phase A:  )  )			



Measurement data	Port under test	AC input power-Line				
H-5_ave_vector_magnitude: 0.814 Amp H-5_standard_ave_magnitude: 0.818 Amp H-5_standard_max_magnitude: 0.863 Amp Ratio of H-5_ave_vector / H-5_standard_ave: 0.995						
Phase A = 44.308% of tested Rsce = 33.000, Rsce = 14.622 Phase B = 61.924% of tested Rsce = 33.000, Rsce = 20.435 Phase C = 50.479% of tested Rsce = 33.000, Rsce = 16.658 Minimum Rsce required: Rsce = 20.435						
Remark						



# 4.6 Voltage changes, voltage fluctuations and flicker VERDICT:

ERDICT: PASS

Standard	IEC 61851-21-2
Basic standard	IEC 61000-3-3 &11

# Limits

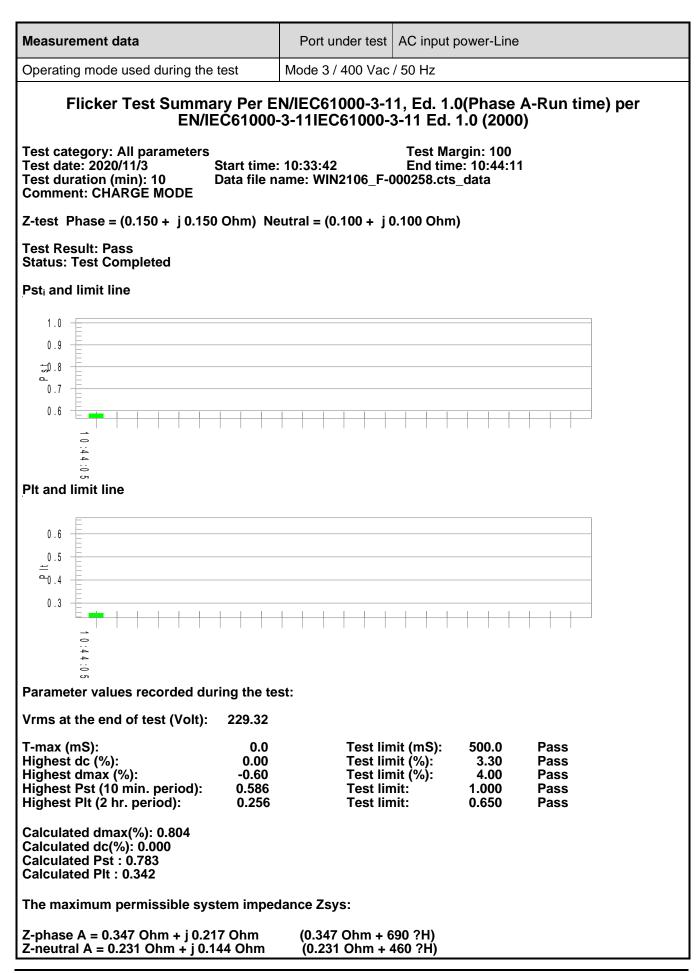
PST (Short term flicker)	$\bowtie$	≤ <b>1</b>	Not Applicable
PLT (Long term flicker)	$\square$	≤ 0,65	Not Applicable
d <sub>C</sub> (Relative Voltage change)	$\boxtimes$	≤ <b>3,3%</b>	Not Applicable
T <sub>max</sub> (Maximum time duration)	$\boxtimes$	≤ 500ms	Not Applicable
d <sub>MAX</sub> (Max. voltage change)	$\square$	≤ <b>4%</b>	6%
		7%	Not Applicable
Supplemental information:			 

### **Performed measurements**

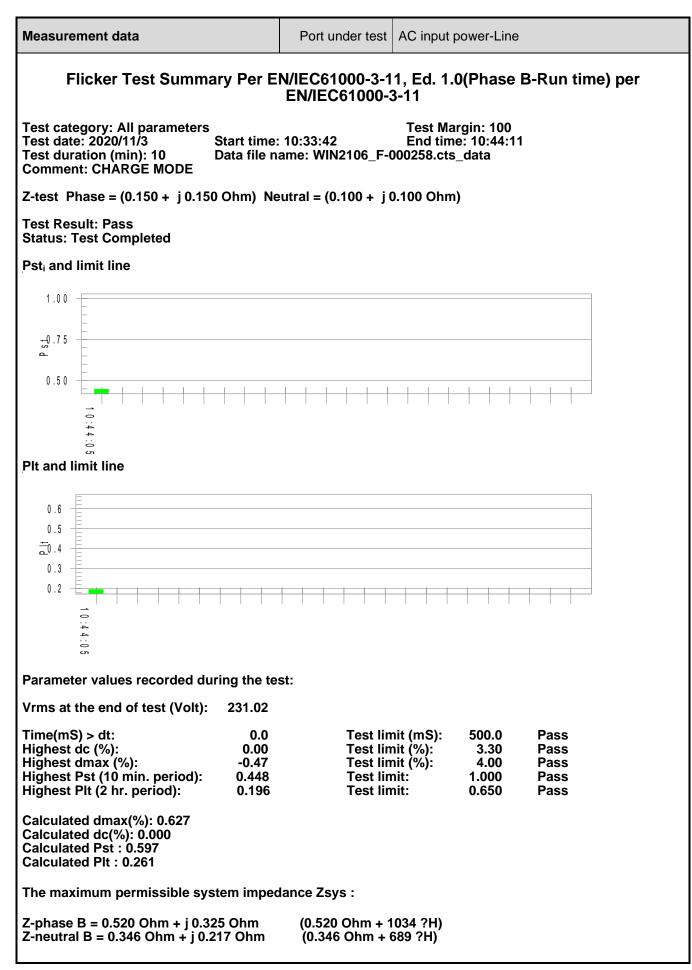
Reason for not performing the measurement(s)		Tests are not necessary because the EUT is unlikely to produce significant voltage fluctuations or flicker (clause 6.1).						
Port under test	Port under test AC Mains power input							
Voltage – Mains [V]	400 Va	400 Vac						
Frequency – Mains [Hz]	50Hz							
Test method		Flickermeter according EN / IEC 61000-4-15:2011						
		Simulation (Clause 4.2.3 of EN / IEC 61000-3-3)						
		Analytical m	ethod (	Clause 4.2.4 of EN	/ IEC 61	1000-3-3)		
		Use of P <sub>st</sub> =	1 curve	(Clause 4.2.5 of El	N / IEC	61000-3-3)		
Observation peroid		10 min.		120 min.		Other:		
		24 times switching according to Annex B						
Operating mode(s) used	Mode 3	3						
Remark								

See next page.











Measurement data Port under test AC input power-Line								
Flicker Test Summary Per E	Flicker Test Summary Per EN/IEC61000-3-11, Ed. 1.0(Phase C-Run time) per EN/IEC61000-3-11							
Test category: All parameters Test date: 2020/11/3 Start time: Test duration (min): 10 Data file n Comment: CHARGE MODE	: 10:33:42 ame: WIN2106_F-0	Test Margin: 100 End time: 10:44:11 000258.cts_data						
Z-test Phase = (0.150 + j 0.150 Ohm) Ne	eutral = (0.100 + j0	).100 Ohm)						
Test Result: Pass Status: Test Completed								
Pst <sub>i</sub> and limit line								
$ \begin{array}{c} 1.0 \\ 0.9 \\ 0.8 \\ 0.7 \\ 0.6 \\ \hline \hline$								
Parameter values recorded during the te	st:							
Vrms at the end of test (Volt): 230.94								
Time(mS) > dt:       0.0         Highest dc (%):       0.00         Highest dmax (%):       -0.47         Highest Pst (10 min. period):       0.551         Highest Plt (2 hr. period):       0.241	Test lin Test lin Test lin Test lin Test lin	nit (%): 4.00 nit: 1.000	Pass Pass Pass Pass Pass					
Calculated dmax(%): 0.630 Calculated dc(%): 0.000 Calculated Pst : 0.736 Calculated Plt : 0.321								
The maximum permissible system imped	dance Zsys :							
Z-phase C = 0.380 Ohm + j 0.238 Ohm Z-neutral C = 0.253 Ohm + j 0.158 Ohm	(0.380 Ohm + 7 (0.253 Ohm + 5							
Remark								



# 5 **IMMUNITY TEST RESULTS**

# 5.1 **Performance (Compliance) criteria**

### [Source: IEC 61851-21-2]

<u>Performance criterion A:</u> The EUT shall continue to operate as intended within the tolerances defined by the EUT manufacturer during and after the application of the appropriate tests. It shall not change the state in which it is operating (i.e. charging shall continue if in charge mode and shall remain idle if in waiting mode).

<u>Performance criterion B:</u> The EUT shall continue to operate as intended within the tolerances defined by the EUT manufacturer at the completion of the applicable tests. Additionally, during the application of the appropriate tests the primary functions of the charger shall be maintained (within the tolerances defined by the EUT manufacturer). Secondary functions (for example displays, etc.) may degrade in performance during the test but shall resume to the original condition subsequent to testing. Subsequent to the application of the applicable test, the EUT shall not have changed the state in which it is operating (i.e. charging shall continue if in charge mode and shall remain idle if in waiting mode).

<u>Performance criterion C:</u> During and after completion of the appropriate tests, the EUT can change to a failsafe condition. This state requires user intervention to restart the charge cycle or the automatic resumption of charging if the safety conditions have been fulfilled as defined in IEC 61851-1:2017 (simplified mode 3).

# 5.1.1 **Performance criteria related to immunity tests**

Immunity test	Performance criteria
Electrostatic discharge	В
Radio-frequency electromagnetic fields	A
Fast transients	В
Surge transient	В
Injected currents (radio-frequency common mode)	А
Power frequency magnetic field immunity	A
Voltage dips and short interruptions	B, C

# 5.1.2 Manufacturer defined performance criteria

Not provided.



# 5.2 **Monitored – Checked Functions / Parameters**

During the immunity tests the following functions of the EUT has/have been monitored/checked.

	Motor speed		Display data				
	Switching		Data storage				
	Standby mode		Sensor functions				
	Temperature		Audible signals				
	Power consumption	$\square$	Others : Screen				
	AC mains input current	$\square$	Others : Output voltage				
	Timing	$\square$	Others : Input current				
	Illumination		Others :				
<u>Supp</u>	Supplementary information :						

Immunity test	Monitored - Checked function(s)/parameter(s) during / after the test	Method
Electrostatic discharge	PASS	Visual
Radio-frequency electromagnetic fields	PASS	Visua
Fast transients	PASS	Visual
Surge transient	PASS	Visual
Injected currents (radio-frequency common mode)	PASS	Visual
Power frequency magnetic field immunity	PASS	Visual
Voltage dips and short interruptions	PASS	Visual
Supplementary information :		



# 5.3 Electrostatic discharge immunity VERDICT: PASS

Electrostatic discharges (ESD) are the result of persons or objects that accumulate static electricity due to for instance walking on synthetic carpets. The ESD can influence the operation of equipment or damage its electronics, either by a direct discharge or indirectly by coupling or radiation. Both effects are simulated during the tests.

### Requirements

Standard	IEC 6	IEC 61851-21-2							
Basic standard	IEC 6	EC 61000-4-2							
Port under test	Enclo	Enclosure							
Air discharges	$\square$	±2 kV	$\square$	±4 kV	$\square$	±8 kV		kV	
Contact discharges		±2 kV	$\boxtimes$	±4 kV		±8 kV		kV	
Number of discharges	≥ 10	≥ 10 per polarity with ≥ 1 sec interval.							
Performance criterion	-	B; During the test degradation is allowed. No change of operating state or stored data is allowed. Refer to the chapter 5.1 for details.							

Set-up	Table-top	Floor standing			
Ambient temperature [°C]	23.8	Relative Humidity air [%] 48			
Voltage – Mains [V]	400 Vac				
Frequency – Mains [Hz]	50Hz				
Operating mode(s) used	Mode 1, Mode 2				

Test Location		Test Voltage [kV] & Polarity	Coupling type	# of applied discharges / polarity	Discharge interval [s]		
$\boxtimes$	Slot/Screen/Bu	itton/LED	±2, ±4, ±8	Air	10	1	
$\boxtimes$	Metal/Screw		±4	Contact	10	1	
$\boxtimes$	HCP top side.		±4	Contact	10	1	
$\boxtimes$	HCP bottom side.		±4	Contact	10	1	
$\boxtimes$	VCP right side.		±4	Contact	10	1	
$\boxtimes$	VCP left side.		±4	Contact	10	1	
$\boxtimes$	VCP front side.		±4	Contact	10	1	
$\boxtimes$	VCP rear side.		±4	Contact	10	1	
Observation(s)       During the test no loss of performance was observed. After the test the EUT functioned as intended. No unacceptable loss of performance or data was observed.         Supplementary information:							



# 5.4 Radio-frequency electromagnetic fields immunity VERDICT: PASS

During the test it is verified if the equipment under test (EUT) has sufficient immunity against radiated electromagnetic fields. Industrial electromagnetic sources, walkie-talkies, radio transmitters, television transmitters and telecommunication equipment including cellular telephones and other emitting devices can generate these fields.

### Requirements

Standard	IEC 6	IEC 61851-21-2						
Basic standard	IEC 6	61000-4-3						
Port under test	Enclo	sure						
AC&DC charging immuni	ty requ	uirements	s – Envir	onmen	ts other than res	idential		
Frequency range		Test leve	I	N	Iodulation	Dwell	time	Step size
80 – 1000 MHz		10 V/m		80%	6 AM (1kHz)	≥ 0,	5 s	≤ 1%
1400 – 2000 MHz		3 V/m		80%	6 AM (1kHz)	≥ 0,	5 s	≤ 1%
2000 – 2700 MHz		3 V/m		80%	6 AM (1kHz)	≥ 0,	5 s	≤ 1%
AC&DC charging immuni	ty requ	uirements	s - Resi	dential	environments			
80 – 1000 MHz		3 V/m		80%	6 AM (1kHz)	≥ 0,	5 s	≤ 1%
1400 – 2000 MHz		3 V/m		80%	6 AM (1kHz)	≥ 0,	5 s	≤ 1%
2000 – 2700 MHz		3 V/m		80%	6 AM (1kHz)	≥ 0,	5 s	≤ 1%
Supplementary information	<u>.</u>							
Performed tests								
Test method	$\square$	⊠ EN 61000-4-3 □ EN 61000-4-20						
Test set-up	$\square$	Equipme	ent on the	e table (	0,8 m height)			
(see annex 3 for photo)		Equipme	ent standi	ng on f	loor (0,05 – 0,15 n	n height)		
Voltage – Mains [V]	400 \	/ac			Frequenc	cy – Main	s [Hz]	50 Hz
Operating mode(s) used	Mode	e 1, Mode	2					
Frequency range (applied)		itenna arization	Test I (appl		Modulation (applied)		l time olied)	Test Criteria
80 – 1000 MHz		Н	10V	/m	80% AM (1kHz	) 1	S	А
(step size 1%)		V	10V	/m	80% AM (1kHz	) 1	S	А
1400 – 2000 MHz		Н	3 V.	/m	80% AM (1kHz	) 1	S	А
(step size 1%)		V	3 V.	/m	80% AM (1kHz	) 1	S	А
2000 – 2700 MHz		Н	3 V.	/m	80% AM (1kHz	) 1	S	А
(step size 1%)		V	3 V.	/m	80% AM (1kHz	) 1	S	A
Exposed side of the EUT		Front (0 <sup>c</sup>	<sup>2</sup> )		Right (90°)		Тор	
	$\square$	Rear (18	30°)	$\square$	Left (270°)		Botto	m
Observation(s)       During the test no loss of performance was observed. After the test the EUT functioned as intended. No unacceptable loss of performance or data was observed.								
Supplementary information	<u>.</u>							



# 5.5 Electrical Fast Transients immunity VERDICT: PASS

The EFT immunity test simulates disturbances by bursts of very short transients caused for example by switching off loads such as an AC motor or bouncing relay contacts. The transients are likely to disturb electronics but less likely to cause damage.

### Requirements

Standard	IEC 61851-21-2	IEC 61851-21-2						
Basic standard	IEC 61000-4-4							
Pulse characteristics	5/50 ns							
AC charging immunity requ	irements - Environn	nents other than reside	ntial					
Port under test		Test level	Repetition frequency	Duration				
Power input (AC)		± 4000 V	5 KHz	≥1 min. / polarity				
Wired network and signal/ co	ntrol	± 2000 V	5 KHz	≥1 min. / polarity				
СРТ	± 2000 V	5 KHz	≥1 min. / polarity					
AC charging immunity requ	irements - Resident	ial environments						
Power input (AC)	± 1000 V & ± 2000 V	5 KHz	≥1 min. / polarity					
Wired network and signal/ control		± 500 V& ± 2000 V	5 KHz	≥1 min. / polarity				
СРТ	± 2000 V	5 KHz	≥1 min. / polarity					
DC charging immunity requ	irements - Environn	nents other than reside	ntial					
Power input (AC)		± 4000 V	5 KHz	≥1 min. / polarity				
Power input (DC)		± 2000 V	5 KHz	≥1 min. / polarity				
Wired network and signal/ co	ntrol	± 2000 V	5 KHz	≥1 min. / polarity				
СРТ		± 2000 V	5 KHz	≥1 min. / polarity				
DC charging immunity requ	irements - Resident	ial environments	•					
Power input (AC)		± 2000 V	5 KHz	≥1 min. / polarity				
Power input (DC)		± 2000 V	5 KHz	≥1 min. / polarity				
Wired network and signal/ co	ntrol	± 2000 V	5 KHz	≥1 min. / polarity				
CPT	± 2000 V	5 KHz	≥1 min. / polarity					
<sup>1)</sup> Only applicable to ports interfa	cing with cables whose to	tal length may exceed 3 m	•	•				

<sup>1)</sup> Only applicable to ports interfacing with cables whose total length may exceed 3 m.

<sup>2)</sup> Not applicable to input ports intended for connection to a battery or a rechargeable battery which must be removed or disconnected from the apparatus for recharging. Apparatus with a DC power input port intended for use with an AC–DC power adaptor shall be tested on the AC power input of the AC- DC power adaptor specified by the manufacturer or, where none is so specified, using a typical AC–DC power adaptor. The test is applicable to DC power input ports intended to be connected permanently to cables longer than 3 m.



Voltage – Mains [V]	400 \	400 Vac				
Frequency – Mains [Hz]	50 Hz	50 Hz				
Operating mode(s) used	Mode 1, Mode 2					
Test Set-up	Equipment standing on floor at $(0,1 \pm 0,01)$ m above ground plane					
(see annex 3 for photo)	Equipment on the table $(0,1 \pm 0,01)$ m above ground plane					
		Artificial hand applied. Location refer to chapter 9.				
Coupling	$\square$	Common mode 🔲 Other:				

Port under test	Test Voltage &Polarity	Repetition Frequency	Test duration / polarity	Injection method		bd	
Power input (AC)	±4KV	5 KHz	120 s	$\boxtimes$			Clamp
СРТ	±2KV	5 KHz	120 s				Clamp
Signal	±2KV	5 KHz	120 s		CDN	$\square$	Clamp
During the test no loss of performance was observed. After the test the EUTObservation(s)functioned as intended. No unacceptable loss of performance or data was observed.							
Supplementary information:							



# 5.6 Surge transient immunity

VERDICT: PASS

The surge transient immunity test simulates the surges that are caused by over-voltages due to indirect (induced) lightning transients. The pulse is a slow transient with high-energy contents and due to its long duration may cause damage to an unprotected EUT.

### Requirements

Standard	IEC 61851-21-2					
Basic standard	IEC 61000-4-5					
Pulse characteristics	1,2/50µs Voltage; 8/20	)µs Current				
Repetition rate	≤ 60 secs. (for each te	est level and phase	angle)			
Number of pulses	5 pulses (at each pola	arity and phase ang	le)			
AC charging immunity requirements - Environments other than residential						
		Test level & Pol	arity & Coupling	Phase angle		
Port		Line to Line 1)	Line to Earth 1)	[°]		
Power input (AC)		± 2 kV	± 4 kV	0, 90, 180, 270		
Wired network and signal/ control		N/A	± 1 kV			
CPT		±1 kV	± 2 kV	0, 90, 180, 270		
AC charging immunity requiren	nents – Residential er	vironments				
Power input (AC)		±1 kV	± 2 kV	0, 90, 180, 270		
Wired network and signal/ control		N/A	± 1 kV			
CPT		±1 kV	± 2 kV	0, 90, 180, 270		
DC charging immunity requirem	nents – Environment	s other than reside	ential			
Power input (AC)		± 2 kV	± 4 kV	0, 90, 180, 270		
Power input (DC)		±1 kV	± 2 kV			
Wired network and signal/ control		N/A	± 1 kV			
CPT		±1 kV	± 2 kV			
DC charging immunity requirem	nents - Residential e	nvironments				
Power input (AC)		±1 kV	± 1 kV ± 2 kV			
Power input (DC)	±1 kV	± 2 kV				
Wired network and signal/ control	N/A	N/A ± 1 kV				
CPT		± 1 kV	± 2 kV			
<sup>1)</sup> In addition to the specified test level <sup>2)</sup> Only in case of long distance lines,		etailed in IEC 61000-	4-5 should also be sa	itisfied.		

### **Performed tests**

Voltage – Mains [V]	400 Vac
Frequency – Mains [Hz]	50 Hz
Operating mode(s) used	Mode 1, Mode 2
Depetition note	
Repetition rate	60 secs. (for each test level and phase angle)
Number of pulses	5 pulses (at each polarity and phase angle)

See next page

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Zhabei District Shanghai 200436 China TEL: +86-21-6056 7666 / FAX: +86-21-6056 7555



Port under test		Coupling	Test level & Polarity	Phase angle [°]	Test Criteria
$\boxtimes$	Power input (AC)	L1+L2, L1+L3, L2+L3,	±2 kV	0, 90, 180, 270	А
$\boxtimes$	Power input (AC)	L1/L2/L3+PE	±4 kV	0, 90, 180, 270	А
$\boxtimes$	Signal	Tx+Rx	±1 kV		A
$\boxtimes$	Signal	Tx/Rx+PE	±1 kV		A
During the test no loss of performance was observed. After the test the El           Observation(s)         functioned as intended. No unacceptable loss of performance or data w           observed.         observed.					
<u>Supp</u>	blementary information:				



# 5.7 Injected currents (RF common mode) immunity VERDICT: PASS

During this test the immunity of the equipment for induced or conducted electromagnetic fields is checked. Fields generated by radio and other transmitters cause RF voltages in long cables like the mains network. This test reproduces these induced disturbing voltages by injecting them to the EUT via the cabling.

### Requirements

Standard	IEC 61851-21-2								
Basic standard	IEC 61000-4-6								
Frequency range	0,15 – 80 MHz								
AC charging immunity requirements - Environments other than residential									
Port under test		Test level, Uo	Modulation	Step size	Dwell time				
Power input (AC)		10 V	80% AM (1kHz)	≤ 1%	≥ 0,5 s				
Wired network and signal/ co	ontrol	10 V	80% AM (1kHz)	≤ 1%	≥ 0,5 s				
CPT		10 V	80% AM (1kHz)	≤ 1%	≥ 0,5 s				
AC charging immunity req	uirements - Res	idential environn	nents						
Power input (AC)		3 V	80% AM (1kHz)	≤ 1%	≥ 0,5 s				
Wired network and signal/ co	ontrol	3 V	80% AM (1kHz)	≤ 1%	≥ 0,5 s				
CPT		10 V	80% AM (1kHz) ≤ 1%		≥ 0,5 s				
DC charging immunity req	uirements - Env	vironments other	than residential						
Power input (AC)		10 V	80% AM (1kHz)	≤ 1%	≥ 0,5 s				
Power input (DC)		10 V	80% AM (1kHz)	≤ 1%	≥ 0,5 s				
Wired network and signal/ co	ontrol	10 V	80% AM (1kHz)	≤ 1%	≥ 0,5 s				
CPT		10 V	80% AM (1kHz)	≤ 1%	≥ 0,5 s				
DC charging immunity req	uirements - Res	idential environn	nents						
Power input (AC)		3 V	80% AM (1kHz)	≤ 1%	≥ 0,5 s				
Power input (DC)		3 V	80% AM (1kHz)	≤ 1%	≥ 0,5 s				
Wired network and signal/ co	ontrol	3 V	80% AM (1kHz)	≤ 1%	≥ 0,5 s				
СРТ		10 V	80% AM (1kHz)	≤ 1%	≥ 0,5 s				
<ol> <li>Only applicable to ports interfacing with cables whose total length, may exceed 3 m.</li> <li>DC connections between parts of equipment/system which are not connected to a DC distribution network are treated as I/O signal/control ports.</li> </ol>									

See next page



Test method (applied)		i i e que e i e ge			ulation plied)	Step size (applied)
EN 61000-4-6		0,15 – 80 M	Hz	80% A	M (1kHz)	1%
Voltage – Mains [V]	400 \	/ac	50 Hz			
Operating mode(s) used	Mode	e 1, Mode 2				
Test set-up		Equipment star	nding on floor	at (0,1 ± 0,0	)1) m above gro	ound plane.
(see annex 3 for photo)	$\square$	Equipment on t	he table (0,1	± 0,01) m at	oove ground pla	ane.
		Artificial hand a	applied. Locat	tion refer to A	Annex 3.	
Port under test		Test Level (applied	Injection method		Dwell time (applied)	Test Criteria
AC input power		10 V	CDN		3 s	А
СРТ		10 V	Cla	mp	3 s	A
Signal		10 V	Cla	mp	3 s	А
Observation(s)       During the test no loss of performance was observed. After the test the EUT functioned as intended. No unacceptable loss of performance or data was observed.         Supplementary information:						
<u></u>	<u></u>					



5.8	Power frequency magnetic field immunity	VERDICT:	PASS

Magnetic fields caused by for example nearby mains frequency transformers may disturb equipment with sensitivity for these type of disturbances such as CRT monitors.

# Requirements

Standard	IEC 61851-21-2				
Basic standard	IEC 61000-4-8				
Port under test	Enclosure				
Field atranath	3 A/m, 30 A/m <sup>1)</sup> , 100 A/m <sup>2)</sup>				
Field strength	5 A/III, 50 A/III <sup>-/</sup>				
Test Frequency	50 / 60 Hz				
Notes: Applicable only to apparatus containing devices susceptible to magnetic fields.					
<sup>1)</sup> Apply for systems $\leq$ 32 A;					
<sup>2)</sup> Apply for systems > 32 A					

Reason for not performing the test		The test is not applicable as the apparatus does not contain a components susceptible to this low-frequency magnetic fields.				
Voltage – Mains [V]	400 Vac					
Frequency – Mains [Hz]	50 Hz	50 Hz				
Operating mode(s) used	Mode 1, Mode 2					
Test set-up	$\square$	Single Coil. Dimensions: 1 m x 1 m				
(see annex 3 for photo)		Single Coil. Dimensions: 2 m x 2 m				
		Homogeneous field (Helmholtz coil). Dimensions: 1 m x 1 m				
	0,1 m above metal surface					

Axis under test		Tested Field strength	Test Frequency	Test Duration	Test Criteria		
$\boxtimes$	X-axis	100 A/m	50 Hz	5 mins	А		
$\boxtimes$	Y-axis	100 A/m	50 Hz	5 mins	А		
Z-axis		100 A/m	100 A/m 50 Hz 5		A		
Observation(s)       During the test no loss of performance was observed. After the test the EUT functioned as intended. No unacceptable loss of performance or data was observed.							
Supplementary information:							



# 5.9 **Power supply interruptions and dips immunity VERDICT: PASS**

The purpose of the test is to verify the immunity of the equipment against voltage dips and voltage interruptions. It helps to ensure that the equipment functions properly (as expected and safely) with power supply fluctuations. Voltage dips and interruptions are caused by faults in the LV, MV, HV networks (short-circuit or ground faults).

### Requirements

Standard	IEC 61851-21-2						
Basic standard		IEC 61000-4-11 (≤16 A) IEC 61000-4-34 (>16 A)					
# of dips & interruptions	3 dips / interrupti	ons for eac	h test leve	el and phase angle			
Interval between events	≥ 10 seconds						
Port under test	Test level	Period (Cycles)		Performance Criterion			
Port under test	l'est level	50 Hz	60 Hz				
	40%	10	12	B; Refer to the chapter 5.1 for details.			
Power input(AC)	70%	25	30	B; Refer to the chapter 5.1 for details.			
Power input (AC)	0%	1	1	B; Refer to the chapter 5.1 for details.			
	0%	250	300	C; Refer to the chapter 5.1 for details.			

NOTE: Where the equipment has a rated voltage range the following shall apply:

- If the voltage range does not exceed 20% of the lower voltage specified for the rated voltage range. A single voltage within that range may be selected for testing.

- In all other cases, the test procedure shall be applied for both the lowest and highest voltages declared in the voltage range.

Unom [Vac]	Terminal	Test level [% U <sub>NOM</sub> ]	Duration [cycles] 50 Hz	Repetion rate [s]	Number of dips per test	Phase angle [°]	Test Criteria
230	L-N	40	10	10	3	0,45,90,135,180, 225,270,315	A Note 1
230	L-N	70	25	10	3	0,45,90,135,180, 225,270,315	A Note 1
230	L-N	0	1	10	3	0,45,90,135,180, 225,270,315	A Note 1
230	L-N	0	250	10	3	0,45,90,135,180, 225,270,315	C Note 2
Operating used	mode(s)	Mode 1, N	lode 2				
Observation(s) Note 1: During the test no functioned as intended. No Note 2: Dips to 0%, Duration by user.				unacceptab	le loss of perfo	ormance or data wa	s observed.
Supplementary information:							



# 6 IDENTIFICATION OF THE EQUIPMENT UNDER TEST

The photographs show the tested device.











# 7 ANNEX 1 - MEASUREMENT UNCERTAINTIES

The table(s) below show(s) measurment uncertainties of the EMC test set-ups. The reported expanded uncertainties are based on a standard uncertainty multiplied by a coverage factor of k=2, providing a level of confidence of approximately 95%.

Test Item	Uncertainty
	3.16dB (9k~150kHz Conduction 2#)
Conducted Emission	2.90dB (150k-30MHz Conduction 2#)
Radiated Emission Uncertainty(	4.40dB (30M~1GHz Polarize: H)
3m 3# Chamber)	5.04dB (30M~1GHz Polarize: V)
	4.94dB (1~6GHz)
Flicker test	0.07%
Harmonic test	1.8%
	1.45 (Using CDN Test)
C/S Test	2.37 (Using EM Clamp Test)
	2.10dB (80MHz-200MHz)
R/S Test	1.76dB (200MHz-1000MHz)
	<b>0.6</b> °C
Emperature and humidity	4%



# 8 ANNEX 2 – USED EQUIPMENT

# Location: EMTEK (SHENZHEN) CO., LTD.

# For Power Line Conducted Emission Measurement

Equipment	Manufacturer	Model No.	Serial No.	Cal. date	Cal. Interval
EMI Test Receiver	Rohde &	FSCI 104045 May 17 2020	May 17, 2020	1)/0.07	
	Schwarz	ESCI	ESCI 101045	May 17, 2020	1Year
PULSE LIMTER	Rohde &	ESH3-Z2	100107 May 16, 202	May 16, 2020	1Year
	Schwarz	E3H3-22	100107	Way 10, 2020	
AMN	Schwarzbeck	NNLK 8129	8129203	May 16, 2020	1Year

# For Radiated Emission Measurement

Equipment	Manufacturer	Model No.	Serial No.	Cal. date	Cal. Interval
EMI Test Receiver	Rohde & Schwarz	ESU 26	100154	May 17, 2020	1Year
Pre-Amplifie	Lunar EM	LNA10M1G-40	J1011130912001	May 17, 2020	1Year
Bilog Antenna	Schwarzbeck	VULB9163	659	Nov 10, 2018	2 Year
EMI Test Receiver	Rohde & Schwarz	ESU 26	100154	May 17, 2020	1Year
Horn antenna	Schwarzbeck	BBHA9120D	9120D-1177	June 12, 2018	2 Year
Pre-Amplifie	SKET	LNPA_0118G- 45	SK2019051801	May 17, 2020	1Year
Receiver	Rohde & Schwarz	ESR7(10HZ- 7GHZ)	N/A	May 16, 2020	1 Year
Magnetic Field Antenna	Schwarzbeck	FESP 5133- 7/41	282	July 04, 2020	2 Year

### For Harmonic Current / Flicker Measurement

Equipment	Manufacturer	Model No.	Serial No.	Cal. date	Cal. Interval
45KVA AC Power	Teseq	NSG 1007-	1305A02873	May 17,	1 Year
source	Teseq	45/45KVA	1303A02073	2020	i ieai
Signal conditioning	Teseq	CCN 1000-3	1305A02873	May 17,	1 Year
Unit	Teseq	CCN 1000-3	1303A02073	2020	i ieai
Impedance network	Teseq	INA2197/37A	1305A02873	May 17,	1 Year
Impedance network	Тезеч		1303A02073	2020	i ieai
Impedance network	Teseq	INA 2196/75A	1305A02874	May 17,	1 Year
Impedance network	Тезеч	1117 2130/137	1303702074	2020	i ieai
Profline 2100 AC	Teseq	NSG 2200-3	A22714	May 17,	1 Year
Switching Unit	resey	1400 2200-0	722114	2020	i ieai



# For Electrostatic Discharge Immunity Test

Equipment	Manufacturer	Model No.	Serial No.	Cal. date	Cal. Interval
ESD Tester	TESEQ AG	NSG 438A	130	May 17, 2020	1 Year

# For RF Strength Susceptibility Test

Equipment	Manufacturer	Model No.	Serial No.	Cal. date	Cal. Interval
Power Amplifier	MILMEGA	AS0102-55	1018770	May 17, 2020	1 Year
50ohm Diode Power Sensor	BOONTON	51011EMC	34236	May 17, 2020	1 Year
RF Power Meter. Dual Channel	BOONTON	4232A	10539	May 17, 2020	1 Year
LogPer. Antenna	SCHWARZBECK	VULP 9118E	811	N/A	N/A
Signal Generator	Agilent	N5181A	MY50145187	May 17, 2020	1 Year
50ohm Diode Power Sensor	BOONTON	51011EMC	36164	May 17, 2020	1 Year
Broad-Band Horn Antenna	SCHWARZBECK	STLP 9149	9149-227	N/A	N/A
Field Strength Meter	DARE	RSS1006A	10100037SNO22	May 17, 2020	1 Year
Multi-function interface system	DARE	CTR1009B	12100250SNO72	N/A	N/A
Automatic switch group	DARE	RSW1004A	N/A	N/A	N/A
Power Amplifier	MILMEGA	AS1860-50	1059346	May 17, 2020	1 Year
Power Amplifier	MILMEGA	80RF1000-175	1059345	May 17, 2020	1 Year

# For Electrical Fast Transient / Burst Immunity Test

Equipment	Manufacturer	Model No.	Serial No.	Cal. date	Cal. Interval
Burst Tester	HAEFELY	PEFT4010	080981-16	May 16, 2020	1Year
Coupling Clamp	HAEFELY	IP-4A	147147	May 16, 2020	1Year
Three phase CDN	Teseq	CDN 163	202	May 16, 2020	1 Year



# For Surge Immunity Test

Equipment	Manufacturer	Model No.	Serial No.	Cal. date	Cal. Interval
Controller	HAEFELY	Psurge 8000	174031	May 16, 2020	1Year
Impulse Module	HAEFELY	PIM 100	174124	May 16, 2020	1Year
Coupling Decoupling	HAEFELY	PCD 130	172181	May 16, 2020	1Year
Coupling Module	HAEFELY	PCD122	174354	May 16, 2020	1Year
Impulse Module	HAEFELY	PIM 120	174435	May 16, 2020	1Year
Coupling Module	HAEFELY	PCD 126A	174387	May 16, 2020	1Year
Impulse Module	HAEFELY	PIM 110	174391	May 16, 2020	1Year

# For Injected Current Susceptibility Test

Equipment	Manufacturer	Model No.	Serial No.	Cal. date	Cal. Interval
Continuous Wave Simulator	EMTEST	CWS500C	0900-12	May 17, 2020	1Year
CDN	EMTEST	CDN-M2	510010010010	May 16, 2020	1Year
CDN	EMTEST	CDN-M3	0900-11	May 16, 2020	1Year
EM Injection Clamp	EMTEST	F-2031-23MM	368	May 16, 2020	1Year
Attenuator	EMTEST	100W 6dB DC- 3G	/	May 16, 2020	1Year
Signal Generator	R&S	SMB100A	103041	May 17, 2020	1Year
Power meter	AGILENT	E4418B	MY45102886	May 17, 2020	1 Year
Three phase CDN	TESEQ	CDN M532S	33799	May 16, 2020	1 Year

# For Magnetic Field Immunity Test

Equipment	Manufacturer	Model No.	Serial No.	Cal. date	Cal. Interval
Magnetic Field Tester	HAEFELY	MAG100	250040.1	May 17, 2020	1Year



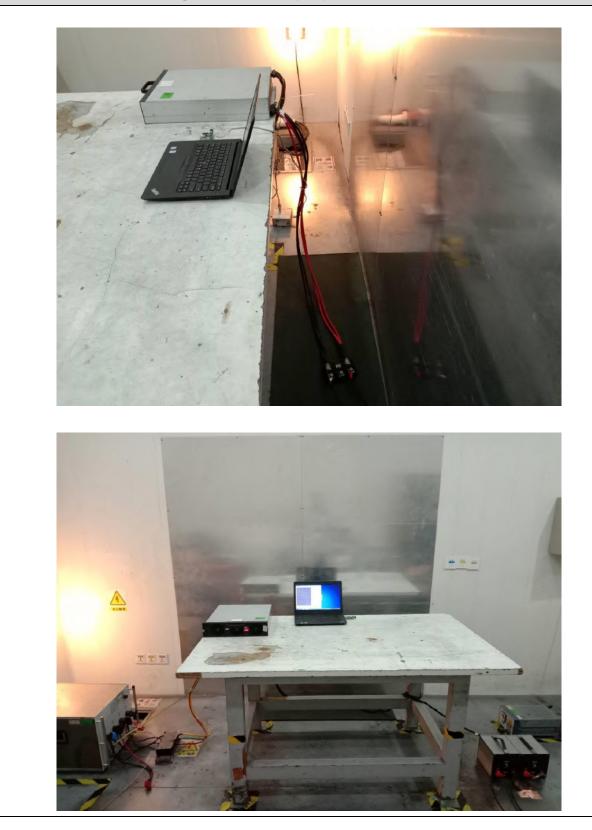
# For Voltage Dips and Interruptions Test

Equipment	Manufacturer	Model No.	Serial No.	Cal. date	Cal. Interval
45KVA AC Power	Teseq	NSG 1007-	1305A02873	May 17,	1 Year
source	Тезеч	45/45KVA	1303A02073	2020	i ieai
Signal conditioning	Teseq	CCN 1000-3	1305A02873	May 17,	1 Year
Unit	Тезеч	CCN 1000-3	1303A02073	2020	i ieai
Impedance network	Teseq	INA2197/37A	1305A02873	May 17,	1 Year
Impedance network	Тезеч		1303A02073	2020	i ieai
Impedance network	Teseq	INA 2196/75A	1305A02874	May 17,	1 Year
	Тезеч	INA 2190/73A	1303A02074	2020	i ieai
Profline 2100 AC	Teseq	NSG 2200-3	A22714	May 17,	1 Year
Switching Unit	reseq	1135 2200-3	722/14	2020	i ieai



# 9 ANNEX 3 - TEST PHOTOS

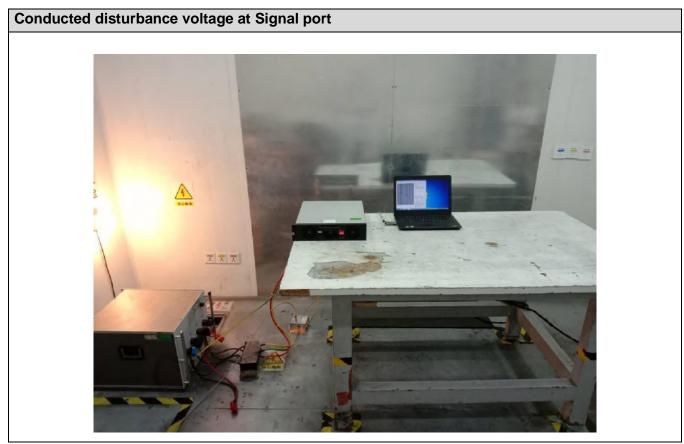
# Conducted disturbance voltage at AC main input port





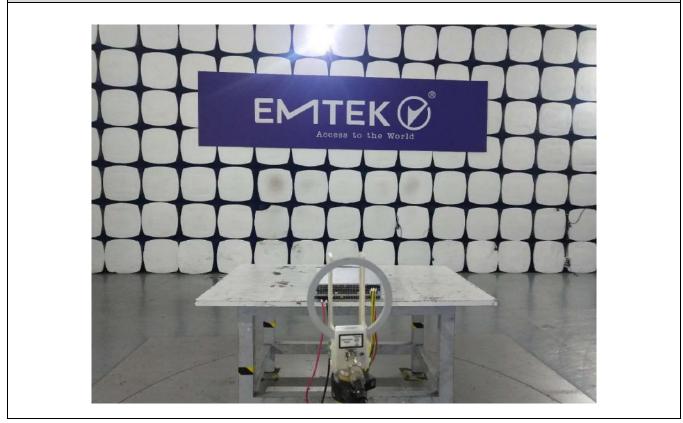
# Conducted disturbance voltage at DC output port







# Radiated electromagnetic disturbances (2 KHz to 185 KHz)



# Radiated electromagnetic disturbances (30 MHz to 1000 MHz)



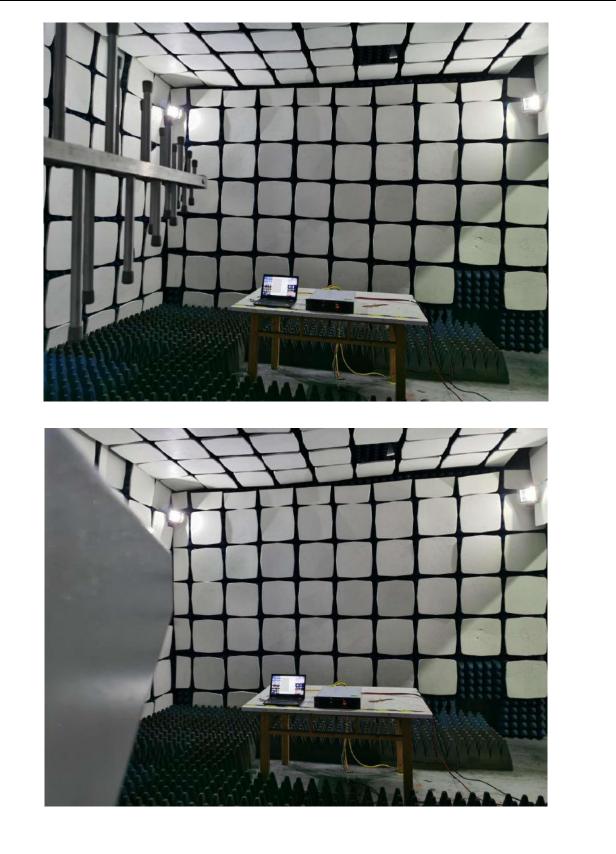
# Harmonic current emissions & Flicker







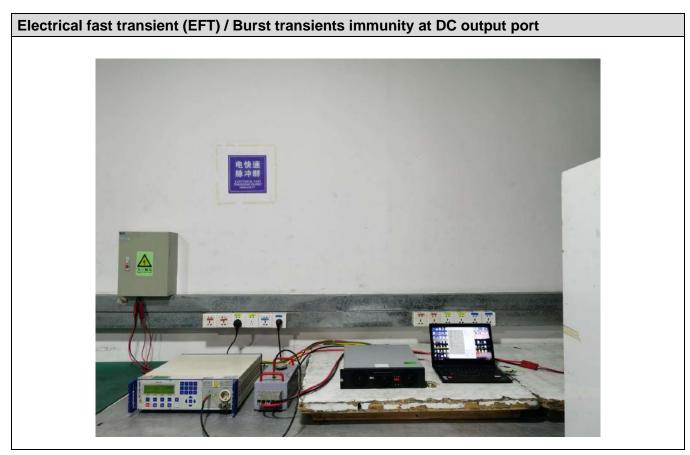
# **Radiated EM Field Immunity**





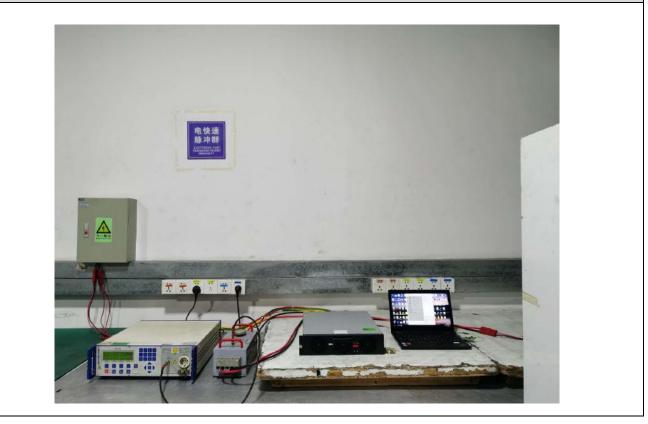
# Electrical fast transient (EFT) / Burst transients immunity at AC main input port

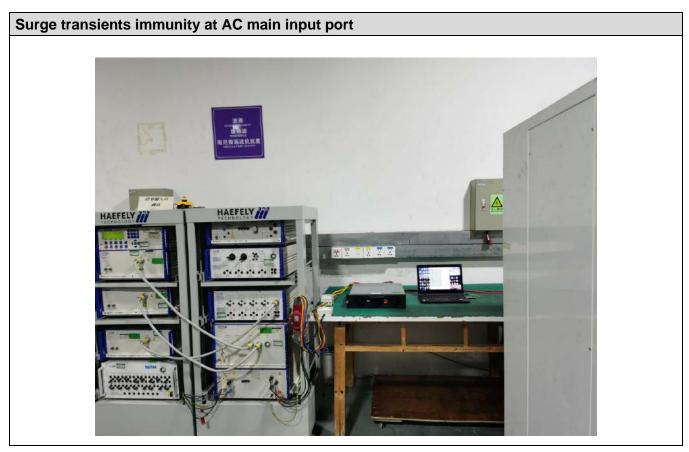






# Electrical fast transient (EFT) / Burst transients immunity at Signal port

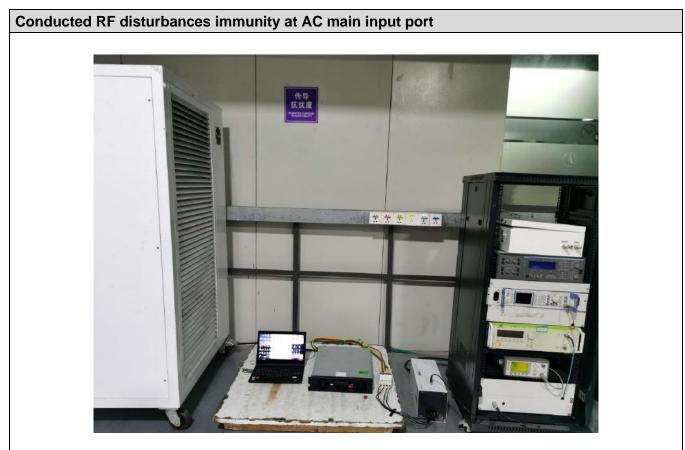






# Surge transients immunity at Signal port

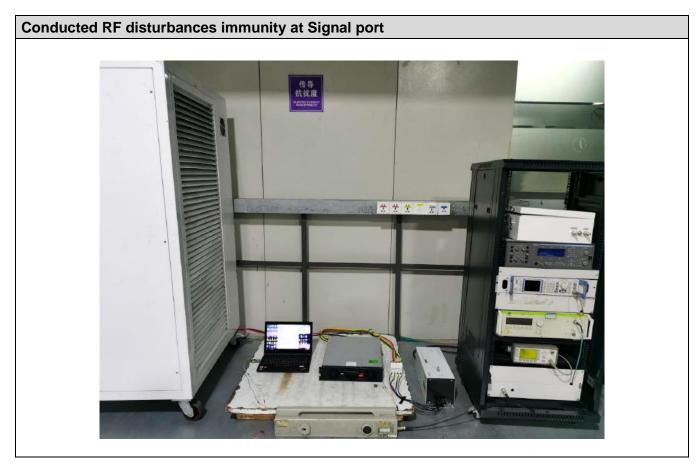






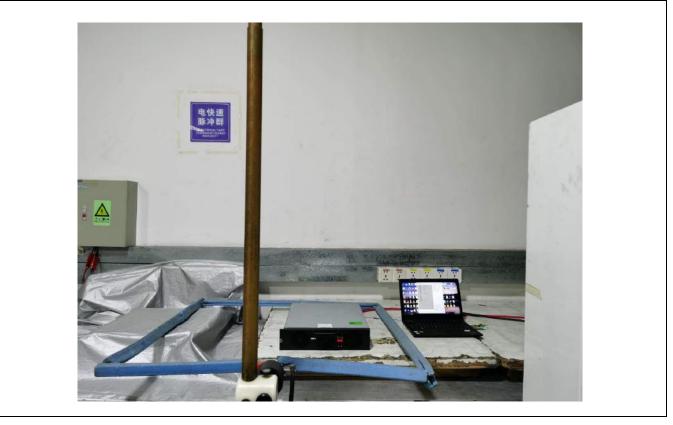
# Conducted RF disturbances immunity at DC output port







# Power frequency magnetic field immunity





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